OneNAND SPECIFICATION

| Product | Part No. | Vcc(core & IO) | Temperature | PKG |
|------------|----------------|------------------|-------------|--------------------|
| | KFG2816Q1M-DEB | 1.8V(1.7V~1.95V) | Extended | 67FBGA(LF)/48TSOP1 |
| OneNAND128 | KFG2816D1M-DEB | 2.65V(2.4V~2.9V) | Extended | 67FBGA(LF)/48TSOP1 |
| | KFG2816U1M-DIB | 3.3V(2.7V~3.6V) | Industrial | 67FBGA(LF)/48TSOP1 |

Version: Ver. 1.0 Date: June 15th, 2005



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Document Title

OneNAND

Revision History

| Revision No. | <u>History</u> | Draft Date | <u>Remark</u> |
|--------------|---|---------------|---------------|
| 0.0 | 1. Initial Issue. | Sep. 9, 2004 | Advance |
| 0.1 | Corrected the errata Revised Cold Reset Added TSOP1 Package Information Revised FBGA package type Added 67FBGA Package Information Revised typical tOTP, tLOCK from 300us to 600us Revised max tOTP, tLOCK from 600us to 1000us Deleted Lock All Block, Lock-Tight All Block Operation Added Endurance and Data Retention Revised Load Data into Buffer Operation Sequence Revised Warm Reset Revised Programmable Burst Read Latency Timing Diagram Revised Multi Block Erase Flow Chart Revised Extended Operating Temperature | Oct. 28, 2004 | Advance |
| 1.0 | 1. Added Copyright Notice in the beginning 2. Corrected Errata 3. Updated Icc2, Icc4, Icc5, Icc6 and I _{SB} 4. Revised INT pin description 5. Added OTP erase case NOTE 6. Revised case definitions of Interrupt Status Register 7. Added a NOTE to Command register 8. Added ECClogSector Information table 9. Removed 'data unit based data handling' from description of Device Operation 10. Revised description on Warm/Hot/NAND Flash Core Reset 11. Revised Warm Reset Timing 12. Revised description for 4-, 8-, 16-, 32-Word Linear Burst Mode 13. Revised OTP operation description 14. Added note for OTP _L in Internal Register Reset 15. Removed all block lock default case after cold or warm reset 16. Added explanation for each prohibited case in protect mode 17. Revised the case of writing other commands during Multi Block Erase routine 18. Added note for Erase Suspend/Resume 19. Added supplemental explanation for ECC Operation 20. Removed classification of ECC error from ECC Operation 21. Removed redundant sentance from ECC Bypass Operation 22. Added technical note for Boot Sequence 23. Added technical note for INT pin connection guide 24. Excluded tOEH from Asynchronous Read Table 25. Revised Asynchronous Read timing diagram for CE don't care mode 26. Revised Load operation timing diagram for CE don't care mode | Jun. 15, 2005 | |

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1. FEATURES

◆ Architecture

• Design Technology: 0.12μm

Voltage Supply

- 1.8V device(KFG2816Q1M) : 1.7V~1.95V - 2.65V device(KFG2816D1M) : 2.4V~2.9V - 3.3V device(KFG2816U1M) : 2.7V~3.6V

Organization

- Host Interface: 16bit

• Internal BufferRAM(3K Bytes)

- 1KB for BootRAM, 2KB for DataRAM

NAND Array

- Page Size : (1K+32)bytes- Block Size : (64K+2K)bytes

♦ Performance

- Host Interface type
- Synchronous Burst Read
- : Clock Frequency: up to 54MHz
- : Linear Burst 4, 8, 16, 32 words with wrap-around
- : Continuous Sequential Burst(512 words)
- Asynchronous Random Read
- : Access time of 76ns
- Asynchronous Random Write
- Programmable Read latency
- Multiple Sector Read
- Read multiple sectors by Sector Count Register(up to 2 sectors)
- Multiple Reset
- Cold Reset / Warm Reset / Hot Reset / NAND Flash Reset
- Power dissipation (typical values, CL=30pF)
- Standby current : 10uA@1.8V device, 15uA@2.65V/3.3V device
- Synchronous Burst Read current(54MHz) : 12mA@1.8V device, 20mA@2.65V/3.3V device
- Load current : 20mA@1.8V device, 20mA@2.65V/3.3V device
- Program current: 20mA@1.8V device, 20mA@2.65V/3.3V device
- Erase current: 15mA@1.8V device, 18mA@2.65V/3.3V device
- Reliable CMOS Floating-Gate Technology
- Endurance : 100K Program/Erase Cycles
- Data Retention: 10 Years

♦ Hardware Features

- Voltage detector generating internal reset signal from Vcc
- Hardware reset input (RP)
- Data Protection
- Write Protection mode for BootRAM
- Write Protection mode for NAND Flash Array
- Write protection during power-up
- Write protection during power-down
- User-controlled One Time Programmable(OTP) area
- Internal 2bit EDC / 1bit ECC
- Internal Bootloader supports Booting Solution in system

♦ Software Features

- Handshaking Feature
- INT pin: Indicates Ready / Busy of OneNAND
- Polling method: Provides a software method of detecting the Ready / Busy status of OneNAND
- Detailed chip information by ID register

◆ Packaging

- Package
- 67ball, 7mm x 9mm x max 1.0mmt, 0.8mm ball pitch FBGA
- 48 TSOP 1, 12mm x 20mm, 0.5mm pitch



2. GENERAL DESCRIPTION

OneNAND is a single-die chip with standard NOR Flash interface using NAND Flash Array. This device is comprised of logic and NAND Flash Array and 3KB internal BufferRAM. 1KB BootRAM is used for reserving bootcode, and 2KB DataRAM is used for buffering data. The operating clock frequency is up to 54MHz. This device is X16 interface with Host, and has the speed of ~76ns random access time. Actually, it is accessible with minimum 4clock latency(host-driven clock for synchronous read), but this device adopts the appropriate wait cycles by programmable read latency. OneNAND provides the multiple sector read operation by assigning the number of sectors to be read in the sector counter register. The device includes one block sized OTP(One Time Programmable), which can be used to increase system security or to provide identification capabilities.



3. PIN DESCRIPTION

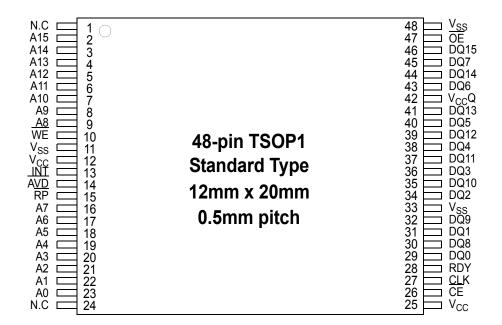
| Pin Name | Type | Nameand Description |
|----------------|------|--|
| Host Interface | | |
| A15~A0 | I | Address Inputs - Inputs for addresses during operation, which are for addressing BufferRAM & Register. |
| DQ15~DQ0 | I/O | Data Inputs/Outputs - Inputs data during program and commands during all operations, outputs data during memory array/register read cycles. Data pins float to high-impedance when the chip is deselected or outputs are disabled. |
| INT | 0 | Interrupt Notifying Host when a command has completed. It is open drain output with internal resistor(~50kohms). After power-up, it is at hi-z condition. Once IOBE is set to 1, it does not float to hi-z condition even when the chip is deselected or when outputs are disabled. |
| RDY | 0 | Ready Indicates data valid in synchronous read modes and is activated while $\overline{\text{CE}}$ is low |
| CLK | I | Clock CLK synchronizes the device to the system bus frequency in synchronous read mode. The first rising edge of CLK in conjunction with AVD low latches address input. |
| WE | ı | Write Enable WE controls writes to the bufferRAM and registers. Datas are latched on the WE pulse's rising edge |
| ĀVD | I | Address Valid Detect Indicates valid address presence on address inputs. During asynchronous read operation, all addresses are latched on AVD's rising edge, and during synchronous read operation, all addresses are latched on CLK's rising edge while AVD is held low for one clock cycle. > Low: for asynchronous mode, indicates valid address; for burst mode, causes starting address to be latched on rising edge on CLK > High: device ignores address inputs |
| RP | I | Reset Pin When low, RP resets internal operation of OneNAND. RP status is don't care during power-up and bootloading. |
| CE | I | Chip Enable CE-low activates internal control logic, and CE-high deselects the device, places it in standby state, and places ADD and DQ in Hi-Z |
| ŌĒ | I | Output Enable OE-low enables the device's output data buffers during a read cycle. |
| Power Supply | | |
| Vcc-Core/Vcc | | Power for OneNAND Core This is the power supply for OneNAND Core. |
| Vcc-IO/Vccq | | Power for OneNAND I/O This is the power supply for OneNAND I/O Vcc-IO is internally connected to Vcc-Core, thus should be connected to the same power supply. |
| Vss | | Ground for OneNAND |
| etc. | | |
| DNU | | Do Not Use Leave it disconnected. These pins are used for testing. |
| NC | | No Connection Lead is not internally connected. |

NOTE:Do not leave power supply(VCC, VSS) disconnected.



4. PIN CONFIGURATION

4.1 TSOP1

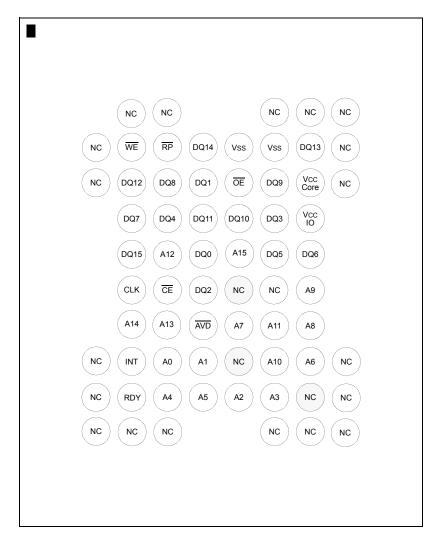


(TOP VIEW, Facing Down)

TSOP1 OneNAND Chip
48pin, 12mm x 20mm, 0.5mm pitch TSOP1



4.2 67FBGA



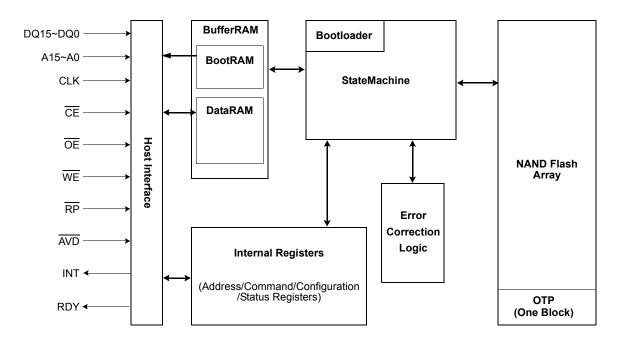
(TOP VIEW, Balls Facing Down)
67ball FBGA OneNAND Chip
67ball, 7.0mm x 9.0mm x max 1.0mmt , 0.8mm ball pitch FBGA

TERMS, ABBREVIATIONS AND DEFINITIONS

| B (capital letter) | Byte, 8bits |
|-----------------------|---|
| W (capital letter) | Word, 16bits |
| b (lower-case letter) | Bit |
| ECC | Error Correction Code |
| Calculated ECC | ECC which has been calculated during load or program access |
| Written ECC | ECC which has been stored as data in the NAND Flash Array or in the BufferRAM |
| BufferRAM | On-chip Internal Buffer consisting of BootRAM and DataRAM |
| BootRAM | A 1KB portion of the BufferRAM reserved for Bootcode buffering |
| DataRAM | A 2KB portion of the BufferRAM reserved for Data buffering |
| Memory | NAND Flash array which is embedded on OneNAND |
| Sector | Partial unit of page, of which size is 512B for main area and 16B for spare area data. It is the minimum Load/Program/Copy-Back program unit while one~two sector operation is available |
| Data unit | Possible data unit to be read from memory to BufferRAM or to be programmed to memory. - 528B of which 512B is in main area and 16B in spare area - 1056B of which 1024B is in main area and 32B in spare area |



5. BLOCK DIAGRAM



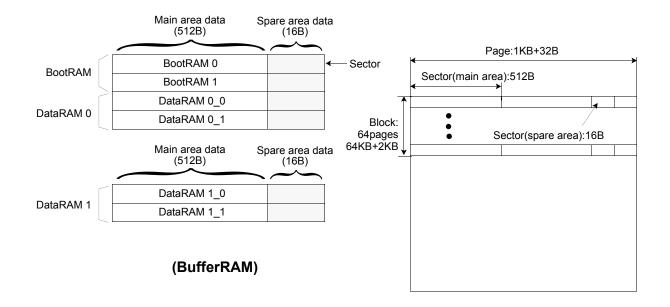
- Host Interface
- BufferRAM(BootRAM, DataRAM)
- Command and status registers
- State Machine (Bootloader is included)
- Error Correction Logic
- Memory(NAND Flash Array, OTP)

NOTE

1) At cold reset, bootloader copies boot code(1K byte size) from NAND Flash Array to BootRAM.

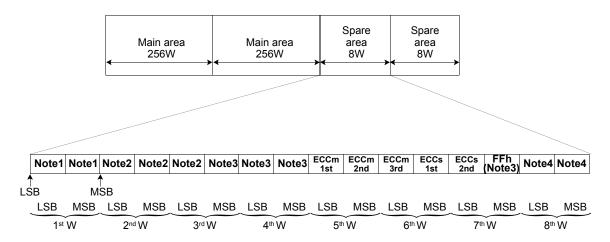
Figure 1. Internal Block Diagram





(NAND array)

Figure 2. BufferRAM and NAND array structure



NOTE

- 1) The 1st word of spare area in 1st and 2nd page of every invalid block is reserved for the invalid block information by manufacturer. Please refer to page 59 about the details.
- 2) These words are managed by internal ECC logic. So it is recommended that the important data like LSN(Logical Sector Number) are written.
- 3) These words are reserved for the future purpose by manufacturer. These words will be dedicated to internal logic.
- 4) These words are for free usage.
- 5) The 5th, 6th and 7th words are dedicated to internal ECC logic. So these words are only readable. The other words are programmable by command.
- 6) ECCm 1st, ECCm 2nd, ECCm 3rd: ECC code for Main area data
- 7) ECCs 1st, ECCs 2nd: ECC code for 2nd and 3rd word of spare area.

Figure 3. Spare area of NAND array assignment



6. ADDRESS MAP For OneNAND NAND Array (word order)

| Block | Block Address | Page and Sector Address ⁽¹⁾ | Size | Block | Block Address | Page and Sector Address ⁽¹⁾ | Size |
|---------|---------------|---|------|---------|---------------|---|------|
| Block0 | 0000h | 0000h~00FDh | 64KB | Block32 | 0020h | 0000h~00FDh | 64KB |
| Block1 | 0001h | 0000h~00FDh | 64KB | Block33 | 0021h | 0000h~00FDh | 64KB |
| Block2 | 0002h | 0000h~00FDh | 64KB | Block34 | 0022h | 0000h~00FDh | 64KB |
| Block3 | 0003h | 0000h~00FDh | 64KB | Block35 | 0023h | 0000h~00FDh | 64KB |
| Block4 | 0004h | 0000h~00FDh | 64KB | Block36 | 0024h | 0000h~00FDh | 64KB |
| Block5 | 0005h | 0000h~00FDh | 64KB | Block37 | 0025h | 0000h~00FDh | 64KB |
| Block6 | 0006h | 0000h~00FDh | 64KB | Block38 | 0026h | 0000h~00FDh | 64KB |
| Block7 | 0007h | 0000h~00FDh | 64KB | Block39 | 0027h | 0000h~00FDh | 64KB |
| Block8 | 0008h | 0000h~00FDh | 64KB | Block40 | 0028h | 0000h~00FDh | 64KB |
| Block9 | 0009h | 0000h~00FDh | 64KB | Block41 | 0029h | 0000h~00FDh | 64KB |
| Block10 | 000Ah | 0000h~00FDh | 64KB | Block42 | 002Ah | 0000h~00FDh | 64KB |
| Block11 | 000Bh | 0000h~00FDh | 64KB | Block43 | 002Bh | 0000h~00FDh | 64KB |
| Block12 | 000Ch | 0000h~00FDh | 64KB | Block44 | 002Ch | 0000h~00FDh | 64KB |
| Block13 | 000Dh | 0000h~00FDh | 64KB | Block45 | 002Dh | 0000h~00FDh | 64KB |
| Block14 | 000Eh | 0000h~00FDh | 64KB | Block46 | 002Eh | 0000h~00FDh | 64KB |
| Block15 | 000Fh | 0000h~00FDh | 64KB | Block47 | 002Fh | 0000h~00FDh | 64KB |
| Block16 | 0010h | 0000h~00FDh | 64KB | Block48 | 0030h | 0000h~00FDh | 64KB |
| Block17 | 0011h | 0000h~00FDh | 64KB | Block49 | 0031h | 0000h~00FDh | 64KB |
| Block18 | 0012h | 0000h~00FDh | 64KB | Block50 | 0032h | 0000h~00FDh | 64KB |
| Block19 | 0013h | 0000h~00FDh | 64KB | Block51 | 0033h | 0000h~00FDh | 64KB |
| Block20 | 0014h | 0000h~00FDh | 64KB | Block52 | 0034h | 0000h~00FDh | 64KB |
| Block21 | 0015h | 0000h~00FDh | 64KB | Block53 | 0035h | 0000h~00FDh | 64KB |
| Block22 | 0016h | 0000h~00FDh | 64KB | Block54 | 0036h | 0000h~00FDh | 64KB |
| Block23 | 0017h | 0000h~00FDh | 64KB | Block55 | 0037h | 0000h~00FDh | 64KB |
| Block24 | 0018h | 0000h~00FDh | 64KB | Block56 | 0038h | 0000h~00FDh | 64KB |
| Block25 | 0019h | 0000h~00FDh | 64KB | Block57 | 0039h | 0000h~00FDh | 64KB |
| Block26 | 001Ah | 0000h~00FDh | 64KB | Block58 | 003Ah | 0000h~00FDh | 64KB |
| Block27 | 001Bh | 0000h~00FDh | 64KB | Block59 | 003Bh | 0000h~00FDh | 64KB |
| Block28 | 001Ch | 0000h~00FDh | 64KB | Block60 | 003Ch | 0000h~00FDh | 64KB |
| Block29 | 001Dh | 0000h~00FDh | 64KB | Block61 | 003Dh | 0000h~00FDh | 64KB |
| Block30 | 001Eh | 0000h~00FDh | 64KB | Block62 | 003Eh | 0000h~00FDh | 64KB |
| Block31 | 001Fh | 0000h~00FDh | 64KB | Block63 | 003Fh | 0000h~00FDh | 64KB |

NOTE 1) The 2nd bit of Page and Sector address register is Don't care. So the address range is bigger than the real range. Even though 2nd bit is set to "1", this bit is always considered "0". Please refer to Start Address 8 register.



| Block | Block Address | Page and Sector Address ⁽¹⁾ | Size | Block | Block Address | Page and Sector Address ⁽¹⁾ | Size |
|---------|---------------|---|------|----------|---------------|---|------|
| Block64 | 0040h | 0000h~00FDh | 64KB | Block96 | 0060h | 0000h~00FDh | 64KB |
| Block65 | 0041h | 0000h~00FDh | 64KB | Block97 | 0061h | 0000h~00FDh | 64KB |
| Block66 | 0042h | 0000h~00FDh | 64KB | Block98 | 0062h | 0000h~00FDh | 64KB |
| Block67 | 0043h | 0000h~00FDh | 64KB | Block99 | 0063h | 0000h~00FDh | 64KB |
| Block68 | 0044h | 0000h~00FDh | 64KB | Block100 | 0064h | 0000h~00FDh | 64KB |
| Block69 | 0045h | 0000h~00FDh | 64KB | Block101 | 0065h | 0000h~00FDh | 64KB |
| Block70 | 0046h | 0000h~00FDh | 64KB | Block102 | 0066h | 0000h~00FDh | 64KB |
| Block71 | 0047h | 0000h~00FDh | 64KB | Block103 | 0067h | 0000h~00FDh | 64KB |
| Block72 | 0048h | 0000h~00FDh | 64KB | Block104 | 0068h | 0000h~00FDh | 64KB |
| Block73 | 0049h | 0000h~00FDh | 64KB | Block105 | 0069h | 0000h~00FDh | 64KB |
| Block74 | 004Ah | 0000h~00FDh | 64KB | Block106 | 006Ah | 0000h~00FDh | 64KB |
| Block75 | 004Bh | 0000h~00FDh | 64KB | Block107 | 006Bh | 0000h~00FDh | 64KB |
| Block76 | 004Ch | 0000h~00FDh | 64KB | Block108 | 006Ch | 0000h~00FDh | 64KB |
| Block77 | 004Dh | 0000h~00FDh | 64KB | Block109 | 006Dh | 0000h~00FDh | 64KB |
| Block78 | 004Eh | 0000h~00FDh | 64KB | Block110 | 006Eh | 0000h~00FDh | 64KB |
| Block79 | 004Fh | 0000h~00FDh | 64KB | Block111 | 006Fh | 0000h~00FDh | 64KB |
| Block80 | 0050h | 0000h~00FDh | 64KB | Block112 | 0070h | 0000h~00FDh | 64KB |
| Block81 | 0051h | 0000h~00FDh | 64KB | Block113 | 0071h | 0000h~00FDh | 64KB |
| Block82 | 0052h | 0000h~00FDh | 64KB | Block114 | 0072h | 0000h~00FDh | 64KB |
| Block83 | 0053h | 0000h~00FDh | 64KB | Block115 | 0073h | 0000h~00FDh | 64KB |
| Block84 | 0054h | 0000h~00FDh | 64KB | Block116 | 0074h | 0000h~00FDh | 64KB |
| Block85 | 0055h | 0000h~00FDh | 64KB | Block117 | 0075h | 0000h~00FDh | 64KB |
| Block86 | 0056h | 0000h~00FDh | 64KB | Block118 | 0076h | 0000h~00FDh | 64KB |
| Block87 | 0057h | 0000h~00FDh | 64KB | Block119 | 0077h | 0000h~00FDh | 64KB |
| Block88 | 0058h | 0000h~00FDh | 64KB | Block120 | 0078h | 0000h~00FDh | 64KB |
| Block89 | 0059h | 0000h~00FDh | 64KB | Block121 | 0079h | 0000h~00FDh | 64KB |
| Block90 | 005Ah | 0000h~00FDh | 64KB | Block122 | 007Ah | 0000h~00FDh | 64KB |
| Block91 | 005Bh | 0000h~00FDh | 64KB | Block123 | 007Bh | 0000h~00FDh | 64KB |
| Block92 | 005Ch | 0000h~00FDh | 64KB | Block124 | 007Ch | 0000h~00FDh | 64KB |
| Block93 | 005Dh | 0000h~00FDh | 64KB | Block125 | 007Dh | 0000h~00FDh | 64KB |
| Block94 | 005Eh | 0000h~00FDh | 64KB | Block126 | 007Eh | 0000h~00FDh | 64KB |
| Block95 | 005Fh | 0000h~00FDh | 64KB | Block127 | 007Fh | 0000h~00FDh | 64KB |

NOTE 1) 2nd bit of Page and Sector address is Don't care. So the address range is bigger than the real range. Even though 2nd bit is set to "1", this bit is always considered "0". Please refer to Start Address 8 register.



| Block | Block Address | Page and Sector Address ⁽¹⁾ | Size | Block | Block Address | Page and Sector Address ⁽¹⁾ | Size |
|----------|---------------|---|------|----------|---------------|---|------|
| Block128 | 0080h | 0000h~00FDh | 64KB | Block160 | 00A0h | 0000h~00FDh | 64KB |
| Block129 | 0081h | 0000h~00FDh | 64KB | Block161 | 00A1h | 0000h~00FDh | 64KB |
| Block130 | 0082h | 0000h~00FDh | 64KB | Block162 | 00A2h | 0000h~00FDh | 64KB |
| Block131 | 0083h | 0000h~00FDh | 64KB | Block163 | 00A3h | 0000h~00FDh | 64KB |
| Block132 | 0084h | 0000h~00FDh | 64KB | Block164 | 00A4h | 0000h~00FDh | 64KB |
| Block133 | 0085h | 0000h~00FDh | 64KB | Block165 | 00A5h | 0000h~00FDh | 64KB |
| Block134 | 0086h | 0000h~00FDh | 64KB | Block166 | 00A6h | 0000h~00FDh | 64KB |
| Block135 | 0087h | 0000h~00FDh | 64KB | Block167 | 00A7h | 0000h~00FDh | 64KB |
| Block136 | 0088h | 0000h~00FDh | 64KB | Block168 | 00A8h | 0000h~00FDh | 64KB |
| Block137 | 0089h | 0000h~00FDh | 64KB | Block169 | 00A9h | 0000h~00FDh | 64KB |
| Block138 | 008Ah | 0000h~00FDh | 64KB | Block170 | 00AAh | 0000h~00FDh | 64KB |
| Block139 | 008Bh | 0000h~00FDh | 64KB | Block171 | 00ABh | 0000h~00FDh | 64KB |
| Block140 | 008Ch | 0000h~00FDh | 64KB | Block172 | 00ACh | 0000h~00FDh | 64KB |
| Block141 | 008Dh | 0000h~00FDh | 64KB | Block173 | 00ADh | 0000h~00FDh | 64KB |
| Block142 | 008Eh | 0000h~00FDh | 64KB | Block174 | 00AEh | 0000h~00FDh | 64KB |
| Block143 | 008Fh | 0000h~00FDh | 64KB | Block175 | 00AFh | 0000h~00FDh | 64KB |
| Block144 | 0090h | 0000h~00FDh | 64KB | Block176 | 00B0h | 0000h~00FDh | 64KB |
| Block145 | 0091h | 0000h~00FDh | 64KB | Block177 | 00B1h | 0000h~00FDh | 64KB |
| Block146 | 0092h | 0000h~00FDh | 64KB | Block178 | 00B2h | 0000h~00FDh | 64KB |
| Block147 | 0093h | 0000h~00FDh | 64KB | Block179 | 00B3h | 0000h~00FDh | 64KB |
| Block148 | 0094h | 0000h~00FDh | 64KB | Block180 | 00B4h | 0000h~00FDh | 64KB |
| Block149 | 0095h | 0000h~00FDh | 64KB | Block181 | 00B5h | 0000h~00FDh | 64KB |
| Block150 | 0096h | 0000h~00FDh | 64KB | Block182 | 00B6h | 0000h~00FDh | 64KB |
| Block151 | 0097h | 0000h~00FDh | 64KB | Block183 | 00B7h | 0000h~00FDh | 64KB |
| Block152 | 0098h | 0000h~00FDh | 64KB | Block184 | 00B8h | 0000h~00FDh | 64KB |
| Block153 | 0099h | 0000h~00FDh | 64KB | Block185 | 00B9h | 0000h~00FDh | 64KB |
| Block154 | 009Ah | 0000h~00FDh | 64KB | Block186 | 00BAh | 0000h~00FDh | 64KB |
| Block155 | 009Bh | 0000h~00FDh | 64KB | Block187 | 00BBh | 0000h~00FDh | 64KB |
| Block156 | 009Ch | 0000h~00FDh | 64KB | Block188 | 00BCh | 0000h~00FDh | 64KB |
| Block157 | 009Dh | 0000h~00FDh | 64KB | Block189 | 00BDh | 0000h~00FDh | 64KB |
| Block158 | 009Eh | 0000h~00FDh | 64KB | Block190 | 00BEh | 0000h~00FDh | 64KB |
| Block159 | 009Fh | 0000h~00FDh | 64KB | Block191 | 00BFh | 0000h~00FDh | 64KB |

NOTE 1) 2nd bit of Page and Sector address is Don't care. So the address range is bigger than the real range. Even though 2nd bit is set to "1", this bit is always considered "0". Please refer to Start Address 8 register.



| Block | Block Address | Page and Sector Address ⁽¹⁾ | Size | Block | Block Address | Page and Sector Address ⁽¹⁾ | Size |
|----------|---------------|---|------|----------|---------------|---|------|
| Block192 | 00C0h | 0000h~00FDh | 64KB | Block224 | 00E0h | 0000h~00FDh | 64KB |
| Block193 | 00C1h | 0000h~00FDh | 64KB | Block225 | 00E1h | 0000h~00FDh | 64KB |
| Block194 | 00C2h | 0000h~00FDh | 64KB | Block226 | 00E2h | 0000h~00FDh | 64KB |
| Block195 | 00C3h | 0000h~00FDh | 64KB | Block227 | 00E3h | 0000h~00FDh | 64KB |
| Block196 | 00C4h | 0000h~00FDh | 64KB | Block228 | 00E4h | 0000h~00FDh | 64KB |
| Block197 | 00C5h | 0000h~00FDh | 64KB | Block229 | 00E5h | 0000h~00FDh | 64KB |
| Block198 | 00C6h | 0000h~00FDh | 64KB | Block230 | 00E6h | 0000h~00FDh | 64KB |
| Block199 | 00C7h | 0000h~00FDh | 64KB | Block231 | 00E7h | 0000h~00FDh | 64KB |
| Block200 | 00C8h | 0000h~00FDh | 64KB | Block232 | 00E8h | 0000h~00FDh | 64KB |
| Block201 | 00C9h | 0000h~00FDh | 64KB | Block233 | 00E9h | 0000h~00FDh | 64KB |
| Block202 | 00CAh | 0000h~00FDh | 64KB | Block234 | 00EAh | 0000h~00FDh | 64KB |
| Block203 | 00CBh | 0000h~00FDh | 64KB | Block235 | 00EBh | 0000h~00FDh | 64KB |
| Block204 | 00CCh | 0000h~00FDh | 64KB | Block236 | 00ECh | 0000h~00FDh | 64KB |
| Block205 | 00CDh | 0000h~00FDh | 64KB | Block237 | 00EDh | 0000h~00FDh | 64KB |
| Block206 | 00CEh | 0000h~00FDh | 64KB | Block238 | 00EEh | 0000h~00FDh | 64KB |
| Block207 | 00CFh | 0000h~00FDh | 64KB | Block239 | 00EFh | 0000h~00FDh | 64KB |
| Block208 | 00D0h | 0000h~00FDh | 64KB | Block240 | 00F0h | 0000h~00FDh | 64KB |
| Block209 | 00D1h | 0000h~00FDh | 64KB | Block241 | 00F1h | 0000h~00FDh | 64KB |
| Block210 | 00D2h | 0000h~00FDh | 64KB | Block242 | 00F2h | 0000h~00FDh | 64KB |
| Block211 | 00D3h | 0000h~00FDh | 64KB | Block243 | 00F3h | 0000h~00FDh | 64KB |
| Block212 | 00D4h | 0000h~00FDh | 64KB | Block244 | 00F4h | 0000h~00FDh | 64KB |
| Block213 | 00D5h | 0000h~00FDh | 64KB | Block245 | 00F5h | 0000h~00FDh | 64KB |
| Block214 | 00D6h | 0000h~00FDh | 64KB | Block246 | 00F6h | 0000h~00FDh | 64KB |
| Block215 | 00D7h | 0000h~00FDh | 64KB | Block247 | 00F7h | 0000h~00FDh | 64KB |
| Block216 | 00D8h | 0000h~00FDh | 64KB | Block248 | 00F8h | 0000h~00FDh | 64KB |
| Block217 | 00D9h | 0000h~00FDh | 64KB | Block249 | 00F9h | 0000h~00FDh | 64KB |
| Block218 | 00DAh | 0000h~00FDh | 64KB | Block250 | 00FAh | 0000h~00FDh | 64KB |
| Block219 | 00DBh | 0000h~00FDh | 64KB | Block251 | 00FBh | 0000h~00FDh | 64KB |
| Block220 | 00DCh | 0000h~00FDh | 64KB | Block252 | 00FCh | 0000h~00FDh | 64KB |
| Block221 | 00DDh | 0000h~00FDh | 64KB | Block253 | 00FDh | 0000h~00FDh | 64KB |
| Block222 | 00DEh | 0000h~00FDh | 64KB | Block254 | 00FEh | 0000h~00FDh | 64KB |
| Block223 | 00DFh | 0000h~00FDh | 64KB | Block255 | 00FFh | 0000h~00FDh | 64KB |

NOTE 1) 2nd bit of Page and Sector address is Don't care. So the address range is bigger than the real range. Even though 2nd bit is set to "1", this bit is always considered "0". Please refer to Start Address 8 register.



Detailed information of Address Map (word order)

• BootRAM(Main area)

-0000h~01FFh: 2(sector) x 512byte(NAND main area) = 1KB

| 0000h~00FFh(512B) | 0100h~01FFh(512B) |
|----------------------|----------------------|
| BootM 0 | BootM 1 |
| (sector 0 of page 0) | (sector 1 of page 0) |

• DataRAM(Main area)

-0200h~05FFh: 4(sector) x 512byte(NAND main area) = 2KB

| 0200h~02FFh(512B) | 0300h~03FFh(512B) | 0400h~04FFh(512B) | 0500h~05FFh(512B) |
|----------------------|----------------------|----------------------|----------------------|
| DataM 0_0 | DataM 0_1 | DataM 1_0 | DataM 1_1 |
| (sector 0 of page 0) | (sector 1 of page 0) | (sector 0 of page 1) | (sector 1 of page 1) |

• BootRAM(Spare area)

-8000h~800Fh: 2(sector) x 16byte(NAND spare area) = 32B

| 8000h~8007h(16B) | 8008h~800Fh(16B) |
|----------------------|----------------------|
| BootS 0 | BootS 1 |
| (sector 0 of page 0) | (sector 1 of page 0) |

• DataRAM(Spare area)

-8010h~802Fh: 4(sector) x 16byte(NAND spare area) = 64B

| 8010h~8017h(| 16B) 8018h~801 | 1Fh(16B) 8020h~8027 | h(16B) 8028h~802Fh(16B) |
|------------------|----------------|--------------------------|------------------------------|
| DataS 0_0 | DataS | 0_1 DataS 1 | _0 DataS 1_1 |
| (sector 0 of pag | (sector 1 o | f page 0) (sector 0 of p | page 1) (sector 1 of page 1) |

^{*}NAND Flash array consists of 1KB page size and 64KB block size.



Spare area assignment

Equivalent to 1word of NAND Flash

| | | | ≺ | | Equivalent to Tword of NAND Flash | | | | | | | | | | | | | |
|---------|-----------------|-----------------|----|------------|-----------------------------------|--------|---------|--------|----------------------|---------|----------|--------|---------|--------|---------|---------|----------------------|---|
| Buf. | Word Address | Byte Address | F | E | D | С | В | Α | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| BootS 0 | 8000h | 10000h | | | | | | | | ı | 31 | | | | | | | |
| | 8001h | 10002h | | | | | | Ma | naged | by In | ternal | ECC I | ogic | | | | | |
| | 8002h | 10004h | | F | Reserv | ed for | the fu | ture u | se | | | Ма | naged | by In | ternal | ECC I | ogic | |
| | 8003h | 10006h | | | | | F | Reserv | ed for | the cu | irrent a | and fu | ture us | se | | | | |
| | 8004h | 10008h | | ECC | Code | for M | ain are | ea dat | a (2 nd) | | | ECC | Code | for M | ain are | ea data | a (1 st) | |
| | 8005h | 1000Ah | | ECC | Code | for Sp | oare ar | ea da | ta (1st) | | | ECC | Code | for M | ain are | ea data | a (3 rd) | |
| | 8006h | 1000Ch | | FFh | (Rese | rved f | or the | future | use) | | | ECC | Code | for Sp | are are | ea dat | a (2 nd) | |
| | 8007h | 1000Eh | | | | | | | | Free | Usage | ! | | | | | | |
| BootS 1 | 8008h | 10010h | | | | | | | | ı | 31 | | | | | | | |
| | 8009h | 10012h | | | | | | Ma | naged | l by In | ternal | ECC I | ogic | | | | | |
| | 800Ah | 10014h | | F | Reserv | ed for | the fu | ture u | se | | | Ма | naged | by In | ternal | ECC I | ogic | |
| | 800Bh | 10016h | | | | | F | Reserv | ed for | the cu | irrent a | and fu | ture us | se | | | | |
| | 800Ch | 10018h | | ECC | Code | for M | ain are | ea dat | a (2 nd) | | | ECC | Code | for M | ain are | ea data | a (1 st) | |
| | 800Dh | 1001Ah | | ECC | Code | for Sp | oare ar | ea da | ta (1st) | | | ECC | Code | for M | ain are | ea data | a (3 rd) | |
| | 800Eh | 1001Ch | | FFh | (Rese | rved f | or the | future | use) | | | ECC | Code | for Sp | are are | ea dat | a (2 nd) | |
| | 800Fh | 1001Eh | | Free Usage | | | | | | | | | | | | | | |
| DataS | 8010h | 10020h | | | | | | | | ı | 31 | | | | | | | |
| 0_0 | 8011h | 10022h | | | | | | Ma | naged | l by In | ternal | ECC I | ogic | | | | | |
| | 8012h | 10024h | | F | Reserv | ed for | the fu | ture u | se | | | Ма | naged | by In | ternal | ECC I | ogic | |
| | 8013h | 10026h | | | | | F | Reserv | ed for | the cu | irrent a | and fu | ture us | se | | | | |
| | 8014h | 10028h | | ECC | Code | for M | ain are | ea dat | a (2 nd) | | | ECC | Code | for M | ain are | ea data | a (1 st) | |
| | 8015h | 1002Ah | | ECC | Code | for Sp | oare ar | ea da | ta (1st) | | | ECC | Code | for M | ain are | ea data | a (3 rd) | |
| | 8016h | 1002Ch | | FFh | (Rese | rved f | or the | future | use) | | | ECC | Code | for Sp | are are | ea dat | a (2 nd) | |
| | 8017h | 1002Eh | | | | | | | | Free | Usage | ! | | | | | | |
| DataS | 8018h | 10030h | BI | | | | | | | | | | | | | | | |
| 0_1 | 8019h | 10032h | | | | | | Ма | naged | l by In | ternal | ECC I | ogic | | | | | |
| | 801Ah | 10034h | | F | Reserv | ed for | the fu | ture u | se | | | Ма | naged | by In | ternal | ECC I | ogic | |
| | 801Bh | 10036h | | | | | F | Reserv | ed for | the cu | irrent a | and fu | ture us | se | | | | |
| | 801Ch | 10038h | | ECC | Code | for M | ain are | ea dat | a (2 nd) | | | ECC | Code | for M | ain are | ea data | a (1 st) | |
| | 801Dh | 1003Ah | | ECC | Code | for Sp | oare ar | ea da | ta (1st) | | | ECC | Code | for M | ain are | ea data | a (3 rd) | |
| | 801Eh | 1003Ch | | FFh | (Rese | rved f | or the | future | use) | | | ECC | Code | for Sp | are are | ea dat | a (2 nd) | |
| | 801Fh | 1003Eh | | | | | | | | Free | Usage | ! | | | | | | |

| | | | Equivalent to 1word of NAND Flash | | | | | | | | | | | | | | | |
|-----------|-----------------|-----------------|---|--|--------|--------|---------|---------|----------------------|--------|----------|--------|---------|--------|---------|---------|----------------------|---|
| Buf. | Word Address | Byte Address | F | E | D | С | В | Α | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| DataS 1_0 | 8020h | 10040h | | | | | 1 | | | E | 31 | ı | ı | | | | | |
| | 8021h | 10042h | | | | | | Ма | naged | by Int | ternal | ECC I | ogic | | | | | |
| | 8022h | 10044h | | F | Reserv | ed for | the fu | ture us | se | | | Ма | naged | by Int | ternal | ECC I | ogic | |
| | 8023h | 10046h | | | | | F | Reserv | ed for | the cu | irrent a | and fu | ture us | se | | | | |
| | 8024h | 10048h | | ECC | Code | for M | ain are | ea data | a (2 nd) | | | ECC | Code | for M | ain are | ea data | a (1 st) | |
| | 8025h | 1004Ah | | ECC | Code | for Sp | are ar | ea dat | a (1st) | | | ECC | Code | for M | ain are | ea data | a (3 rd) | |
| | 8026h | 1004Ch | | FFh(Reserved for the future use) ECC Code for Spare area data (2 nd) | | | | | | | | | | | | | | |
| | 8027h | 1004Eh | | | | | | | | Free | Usage | ! | | | | | | |
| DataS 1_1 | 8028h | 10050h | | | | | | | | Е | 31 | | | | | | | |
| | 8029h | 10052h | | | | | | Ма | naged | by Int | ternal | ECC I | ogic | | | | | |
| | 802Ah | 10054h | | F | Reserv | ed for | the fu | ture u | se | | | Ма | naged | by Int | ternal | ECC I | ogic | |
| | 802Bh | 10056h | Reserved for the current and future use | | | | | | | | | | | | | | | |
| | 802Ch | 10058h | | ECC | Code | for M | ain are | ea data | a (2 nd) | | | ECC | Code | for M | ain are | ea dat | a (1 st) | |
| | 802Dh | 1005Ah | | ECC | Code | for Sp | are ar | ea dat | a (1 st) | | | ECC | Code | for M | ain are | ea data | a (3 rd) | |
| | 802Eh | 1005Ch | | FFh | (Rese | rved f | or the | future | use) | | | ECC | Code | for Sp | are ar | ea dat | a (2 nd) | |
| | 802Fh | 1005Eh | | | | | | | | Free | Usage | ! | | | | | | |

NOTE

- BI: Invalid block Information



>Host can use complete spare area except BI and ECC code area. For example,

Host can write data to Spare area buffer except for the area controlled by ECC logic at program operation.

>OneNAND automatically generates ECC code for both main and spare data of memory during program operation in case of 'with ECC' mode, but does not update ECC code to spare bufferRAM.

>When loading/programming spare area, spare area BufferRAM address(BSA) and BufferRAM sector count(BSC) is chosen via Start buffer register as it is

7. Detailed address map for registers

| Address (word order) | Address (byte order) | Name | Host Access | Description |
|-------------------------|-------------------------|-------------------------------|----------------|---|
| F000h | 1E000h | Manufacturer ID | R | Manufacturer identification |
| F001h | 1E002h | Device ID | R | Device identification |
| F002h | 1E004h | Version ID | R | Version identification |
| F003h | 1E006h | Data Buffer size | R | Data buffer size |
| F004h | 1E008h | Boot Buffer size | R | Boot buffer size |
| F005h | 1E00Ah | Amount of buffers | R | Amount of data/boot buffers |
| F006h | 1E00Ch | Technology | R | Info about technology |
| F007h~F0FFh | 1E00Eh~1E1FEh | Reserved | - | Reserved for User |
| F100h | 1E200h | Start address 1 | R/W | NAND Flash Block address |
| F101h | 1E202h | Start address 2 | R/W | Reserved |
| F102h | 1E204h | Start address 3 | R/W | Destination Block address for Copy back program |
| F103h | 1E206h | Start address 4 | R/W | Destination Page & Sector address for Copy back program |
| F104h | 1E208h | Start address 5 | - | N/A |
| F105h | 1E20Ah | Start address 6 | - | N/A |
| F106h | 1E20Ch | Start address 7 | - | N/A |
| F107h | 1E20Eh | Start address 8 | R/W | NAND Flash Page & Sector address |
| F108h~F1FFh | 1E210h~1E3FEh | Reserved | - | Reserved for User |
| F200h | 1E400h | Start Buffer | R/W | Number Buffer of for the page data transfer to/from the memory and the start Buffer Address The meaning is with which buffer to start and how many buffers to use for the data transfer |
| F201h~F207h | 1E402h~1E40Eh | Reserved | - | Reserved for User |
| F208h~F21Fh | 1E410h~1E43Eh | Reserved | - | Reserved for vendor specific purposes |
| F220h | 1E440h | Command | R/W | Host control and memory operation commands |
| F221h | 1E442h | System Configuration 1 | R, R/W | Memory and Host Interface Configuration |
| F222h | 1E444h | System Configuration 2 | - | N/A |
| F223h~F22Fh | 1E446h~1E45Eh | Reserved | - | Reserved for User |
| F230h~F23Fh | 1E460h~1E47Eh | Reserved | - | Reserved for vendor specific purposes |
| F240h | 1E480h | Controller Status | R | Controller Status and result of memory operation |
| F241h | 1E482h | Interrupt | R/W | Memory Command Completion Interrupt Status |
| F242h~F24Bh | 1E484h~1E496h | Reserved | - | Reserved for User |
| F24Ch | 1E498h | Unlock Start Block Address | R/W | Start memory block address to unlock in Write Protection mode |
| F24Dh | 1E49Ah | Unlock End Block Address | R/W | End memory block address to unlock in Write Protection mode |
| F24Eh | 1E49Ch | Write Protection Status | R | Current memory Write Protection status (unlocked/locked/tight-locked) |
| F24Fh~FEFFh | 1E49Eh~1FDFEh | Reserved | - | Reserved for User |



| Address (word order) | Address (byte order) | Name | Host Access | Description |
|-------------------------|-------------------------|-------------------------------|----------------|--|
| FF00h | 1FE00h | ECC Status Register | R | ECC status of sector |
| FF01h | 1FE02h | ECC Result of main area data | R | ECC error position of Main area data error for first selected Sector |
| FF02h | 1FE04h | ECC Result of spare area data | R | ECC error position of Spare area data error for first selected Sector |
| FF03h | 1FE06h | ECC Result of main area data | R | ECC error position of Main area data error for second selected Sector |
| FF04h | 1FE08h | ECC Result of spare area data | R | ECC error position of Spare area data error for second selected Sector |
| FF05h~FFFFh | 1FE12h~1FF0Ah | Reserved | - | Reserved for vendor specific purposes |



7. Address Register (word order)

7.1 Manufacturer ID Register (R): F000h, default=00ECh

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|----|----|----|----|----|---|-----|-------|---|---|---|---|---|---|---|
| | | | | | | | Mar | nufID | | | | | | | |

ManufID (Manufacturer ID): manufacturer identification, 00ECh for Samsung Electronics Corp.

7.2 Device ID Register (R): F001h, default=refer to Table1

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|----------|----|----|----|----|---|---|---|---|---|---|---|---|---|---|
| | DeviceID | | | | | | | | | | | | | | |

DeviceID (Device ID): Device Identification,

Table 1.

| Device | DeviceID[15:0] |
|------------|----------------|
| KFG2816Q1M | 0004h |
| KFG2816D1M | 0005h |
| KFG2816U1M | 0005h |

7.3 Version ID Register (R): F002h

: N/A



7.4 Data Buffer size Register(R): F003h, default=0400h

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|-------------|----|----|----|----|---|---|---|---|---|---|---|---|---|---|
| | DataBufSize | | | | | | | | | | | | | | |

DataBufSize: total data buffer size in words in the memory interface used for shrinks Equals two buffers of 512 words each(2x512=2^N, N=10)

7.5 Boot Buffer size Register (R): F004h, default=0200h

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|-------------|----|----|----|----|---|---|---|---|---|---|---|---|---|---|
| | BootBufSize | | | | | | | | | | | | | | |

BootBufSize: total boot buffer size in words in the memory interface (512 words=29, N=9)

7.6 Amount of Buffers Register (R): F005h, default=0201h

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|----|----|---------|---------|----|---|---|---|---|---|--------|---------|---|---|---|
| | | | DataBut | fAmount | | | | | | | BootBu | fAmount | | | |

 $\label{eq:definition} DataBufAmount: the amount of data buffer=2(2^N, N=1) \\ BootBufAmount: the amount of boot buffer=1(2^N, N=0) \\$

7.7 Technology Register (R): F006h, default=0000h

| _ | | | | | | | | | | | | | | | | |
|---|----|------|----|----|----|----|---|---|---|---|---|---|---|---|---|---|
| | 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| | | Tech | | | | | | | | | | | | | | |

Tech: technology information, what technology is used for the memory

| Tech | Technology |
|-------------|------------|
| 0000h | NAND SLC |
| 0001h | NAND MLC |
| 0002h-FFFFh | Reserved |



7.8 Start Address1 Register (R/W): F100h, default=0000h

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|----|----|----------|---------|-----|---|---|---|---|---|---|----|---|---|---|
| | | Re | eserved(| 0000000 | 00) | | | | | | | BA | | | |

FBA (NAND Flash Block Address): NAND Flash block address which will be read or programmed or erased.

| Device | Number of Block | FBA |
|--------|-----------------|----------|
| 128Mb | 256 | FBA[7:0] |

7.9 Start Address2 Register (R/W): F101h, default=0000h

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|----|----|----|----|----|--------|---------|---------|---------|---|---|---|---|---|---|
| | | | | | | Reserv | ed(0000 | 0000000 | 000000) | | | | | | |

7.10 Start Address3 Register (R/W): F102h, default=0000h

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|----|----|----------|---------|----|---|---|---|---|---|----|----|---|---|---|
| | | Re | eserved(| 0000000 | | | | | | | FC | ВА | | | |

FCBA (NAND Flash Copy Back Block Address): NAND Flash destination block address which will be copy back programmed.

| Device | Number of Block | FBA |
|--------|-----------------|----------|
| 128Mb | 256 | FBA[7:0] |

7.11 Start Address4 Register (R/W): F103h, default=0000h

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|----|----|----------|---------|-----|---|---|---|---|---|----|---|---|----------|------|
| | • | Re | eserved(| 0000000 | 00) | * | | | | | PA | • | | Reserved | FCSA |

FCPA (NAND Flash Copy Back Page Address): NAND Flash destination page address in a block for copy back program operation. FCPA(default value) = 000000

FCPA range: 000000~111111, 6bits for 64 pages

FCSA (NAND Flash Copy Back Sector Address): NAND Flash destination sector address in a page for copy back program operation.

FCSA(default value) = 0

FCSA range: 0~1, 1bits for 2 sectors



7.12 Start Address5 Register: F104h

: N/A

7.13 Start Address6 Register: F105h

: N/A

7.14 Start Address7 Register: F106h

: N/A

7.15 Start Address8 Register (R/W): F107h, default=0000h

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|----|----|----------|---------|-----|---|---|---|---|----|----|---|---|----------|-----|
| | | Re | served (| (000000 | 00) | | | | | FI | PA | | | Reserved | FSA |

FPA (NAND Flash Page Address): NAND Flash start page address in a block for page read or copy back program or program operation. FPA(default value)=000000

FPA range: 000000~111111 , 6bits for 64 pages

FSA (Flash Sector Address): NAND Flash start sector address in a page for read or copy back program or program operation.

FSA(default value) = 0

FSA range: 0~1, 1bits for 2 sectors

7.16 Start Buffer Register (R/W): F200h, default=0000h

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|---------|----------|----|----|----|----|---|---|---|------|----------|--------|---|---|-----|
| | Reserve | ed(0000) | | | В | SA | | | | Rese | rved(000 | 00000) | | | BSC |

BSC (BufferRAM Sector Count): this field specifies the number of sectors to be read or programmed or copy back programmed.

Its maximum count is 2 sectors at 0(default value)value.

For a single sector access, it should be programmed as value 1 and it should be programmed as value 0 for two sectors.

However internal RAM buffer reached to 1 value(max. value), it counts up to 0 value to satisfy BSC value.

for example) if BSA=1101, BSC=0, then selected BufferRAM are '1101->1100'.

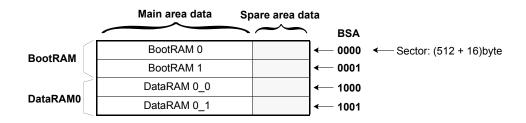
BSA (BufferRAM Sector Address): It is the place where data is placed and specifies the sector 0~1 in the internal BootRAM and DataRAM.

BSA[3] is the selection bit between BootRAM and DataRAM.

BSA[2] is the selection bit between DataRAM0 and DataRAM1.

BSA[0] is the selection bit between Sector0 and Sector1 in the internal BootRAM and DataRAM.

While one of BootRAM or DataRAM0 interfaces with memory, the other RAM is inaccessible.



| | DataRAM 1_0 | ← 1100 |
|----------|-------------|--------|
| DataRAM1 | DataRAM 1_1 | ← 1101 |

| BSC | Number of Sectors |
|-----|-------------------|
| 1 | 1 sector |
| 0 | 2 sectors |



7.17 Command Register (R/W): F220h, default=0000h

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|----|----|----|----|----|---|-----|------|---|---|---|---|---|---|---|
| | | | | | | | Com | mand | | | | | | | |

Command: operation of the memory interface

| CMD | Operation | Acceptable command during busy |
|-------|--|--------------------------------------|
| 0000h | Load single/multiple sector data unit into buffer | 00F0h, 00F3h |
| 0013h | Load single/multiple spare sector into buffer | 00F0h, 00F3h |
| 0080h | Program single/multiple sector data unit from buffer | 00F0h, 00F3h |
| 001Ah | Program single/multiple spare area sector from buffer | 00F0h, 00F3h |
| 001Bh | Copy back program | 00F0h, 00F3h |
| 0023h | Unlock NAND array block(s) from start block address to end block address | - |
| 002Ah | Lock NAND array block(s) from start block address to end block address | - |
| 002Ch | Lock-tight NAND array block(s) from start block address to end block address | - |
| 0071h | Erase Verify Read | 00F0h, 00F3h |
| 0094h | Block Erase | 00F0h, 00F3h |
| 0095h | Multi-Block Erase | 00F0h, 00F3h |
| 00B0h | Erase Suspend | 00F3h |
| 0030h | Erase Resume | 00F0h, 00F3h |
| 00F0h | Reset NAND Flash Core | - |
| 00F3h | Reset OneNAND 1) | - |
| 0065h | OTP Access | 00F0h, 00F3h |

NOTE

This R/W register describes the operation of the OneNAND interface.

Note that all commands should be issued right after INT is turned from ready state to busy state. (i.e. right after 0 is written to INT register.) After any command is issued and the corresponding operation is completed, INT goes back to ready state. (00F0h and 00F3h may be accepted during busy state of some operations. Refer to the rightmost column of the command register table above.)



^{1)&#}x27;Reset OneNAND'(=Hot reset) command makes the registers(except RDYpol, INTpol, IOBE, and OTPL bits) and NAND Flash core into default state as the warm reset(=reset by RP pin).

7.18 System Configuration 1 Register (R, R/W): F221h, default=40C0h

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|-----|----|---------|----|----|----|---|-----|------------|------------|----------|----------------|---|---|---|----------|
| R/W | | R/W R/W | | | | | R/W | R/W | R/W | R/W | R | | | | R |
| RM | | BRL | | | BL | | ECC | RDY pol | INT pol | IOB E | Reserved(0000) | | | | BW PS |

RM (Read Mode): this field specifies the selection between asynchronous read mode and synchronous read mode

| RM | Read Mode |
|----|----------------------------|
| 0 | Asynchronous read(default) |
| 1 | Synchronous read |

BRL (Burst Read Latency): this field specifies the initial access latency in the burst read transfer.

| BRL | Latency Cycles |
|-----|------------------|
| 000 | 8(N/A) |
| 001 | 9(N/A) |
| 010 | 10(N/A) |
| 011 | 3(up to 40MHz) |
| 100 | 4(default, min.) |
| 101 | 5 |
| 110 | 6 |
| 111 | 7 |

BL (Burst Length): this field specifies the size of burst length during Sync. burst read. Wrap around and linear burst.

| BL | Burst Length(Main) | Burst Length(Spare) | | | | | | | | | |
|---------|--------------------|---------------------|--|--|--|--|--|--|--|--|--|
| 000 | Continuou | us(default) | | | | | | | | | |
| 001 | 4 words | | | | | | | | | | |
| 010 | 8 wo | 8 words | | | | | | | | | |
| 011 | 16 w | vords | | | | | | | | | |
| 100 | 32 words | N/A | | | | | | | | | |
| 101~111 | Reserved | | | | | | | | | | |

ECC: Error Correction Operation,

0=with correction(default), 1=without correction(by-passed)

RDYpol: RDY signal polarity 0=low for ready, 1=high for ready((default)

INTpol: INT Pin polarity

0=low for Interrupt pending , 1=high for Interrupt pending (default)

| INTpol | INT bit of Interrupt Status Register | INT Pin output |
|--------|--------------------------------------|----------------|
| 0 | 0 | 1 |
| 1 | 0 | 0 |

IOBE: I/O buffer enable for INT and RDY signals, INT and RDY outputs are HighZ at power-up, bit 7 and 6 become valid after IOBE is set to 1. IOBE can be reset only by Cold reset or by writing 0 to bit 5 of System Configuration 1 register. 0=disable(default), 1=enable

BWPS: boot buffer write protect status,

0=locked(fixed)



7.19 System Configuration 2 Register: F222h

: N/A

7.22 Controller Status Register (R): F240h, default=0000h

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|------|------|------|------|-------|-------|-----|-----|------|------|---|------|---------|-------|---|-----------|
| OnGo | Lock | Load | Prog | Erase | Error | Sus | PRp | RSTB | OTPL | | Rese | rved(00 | 0000) | | TO (0) |

OnGo: this bit shows the overall internal status of OneNAND 0=ready, 1=busy

Lock: this bit shows whether host loads data from NAND Flash array into locked BootRAM or programs/erases locked block of NAND Flash array.

| Lock | Locked/Unlocked Check Result |
|------|------------------------------|
| 0 | Unlocked |
| 1 | Locked |

Error (Current Sector/Page Write Result): this bit shows current sector/page Load/Program/Copy Back Program/Erase result of flash memory or whether host puts invalid command into the device.

| Error | Current Sector/Page Load/Program/CopyBack. Program/Erase Result and Invalid Command Input |
|-------|---|
| 0 | Pass |
| 1 | Fail |

Sus (Erase Suspend/Resume):this bit shows the Erase Suspend Status.

| Sus | Erase Suspend Status |
|-----|-----------------------|
| 0 | Erase Resume(Default) |
| 1 | Erase Suspend |

OTPL (OTP Lock Status):this bit shows OTP block is locked or unlocked. OTPL bit is automatically updated at power-on.

| OTP∟ | OTP Locked/Unlocked Status |
|------|--|
| 0 | OTP Block Unlock Status(Default) |
| 1 | OTP Block Lock Status(Disable OTP Program/Erase) |

 \mbox{TO} (Time Out): time out for read/program/copy back program/erase 0=no time out(fixed)

Load: this bit shows the Load operation status 0=ready(default), 1=busy or error case, refer to the table 3

Prog (Program Busy): this bit shows the Program operation status 0=ready(default), 1=busy or error case, refer to the table 3

Erase (Erase Busy): this bit shows the Erase operation status 0=ready(default), 1=busy or error case, refer to the table 3

RSTB (Reset Busy): this bit shows the Reset operation status 0=ready(default), 1=busy or error case, refer to the table 3



Table 3. Controller Status Register output for modes.

| Mada | Controller Status Register [15:0] | | | | | | | | | | | | | |
|---|-----------------------------------|------|------|------|-------|-------|-----|-------------|------|------|-------------|----|--|--|
| Mode | OnGo | Lock | Load | Prog | Erase | Error | Sus | Reserved(0) | RSTB | OTPL | Reserved(0) | то | | |
| Load Ongoing | 1 | 0 | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0/1 | 00000 | 0 | | |
| Program Ongoing | 1 | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 0 | 0/1 | 00000 | 0 | | |
| Erase Ongoing | 1 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 0/1 | 00000 | 0 | | |
| Reset Ongoing | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0/1 | 00000 | 0 | | |
| Multi-Block Erase Ongoing | 1 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 0/1 | 00000 | 0 | | |
| Erase Verify Read Ongoing | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0/1 | 00000 | 0 | | |
| Load OK | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0/1 | 00000 | 0 | | |
| Program OK | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0/1 | 00000 | 0 | | |
| Erase OK | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0/1 | 00000 | 0 | | |
| Erase Verify Read OK ³⁾ | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0/1 | 00000 | 0 | | |
| Load Fail ¹⁾ | 0 | 0 | 1 | 0 | 0 | 1 | 0 | 0 | 0 | 0/1 | 00000 | 0 | | |
| Program Fail | 0 | 0 | 0 | 1 | 0 | 1 | 0 | 0 | 0 | 0/1 | 00000 | 0 | | |
| Erase Fail | 0 | 0 | 0 | 0 | 1 | 1 | 0 | 0 | 0 | 0/1 | 00000 | 0 | | |
| Erase Verify Read Fail ³⁾ | 0 | 0 | 0 | 0 | 1 | 1 | 0 | 0 | 0 | 0/1 | 00000 | 0 | | |
| Load Reset ²⁾ | 0 | 0 | 1 | 0 | 0 | 1 | 0 | 0 | 1 | 0/1 | 00000 | 0 | | |
| Program Reset | 0 | 0 | 0 | 1 | 0 | 1 | 0 | 0 | 1 | 0/1 | 00000 | 0 | | |
| Erase Reset | 0 | 0 | 0 | 0 | 1 | 1 | 0 | 0 | 1 | 0/1 | 00000 | 0 | | |
| Erase Suspend | 0 | 0 | 0 | 0 | 1 | 0 | 1 | 0 | 0 | 0/1 | 00000 | 0 | | |
| Program Lock | 0 | 1 | 0 | 1 | 0 | 1 | 0 | 0 | 0 | 0/1 | 00000 | 0 | | |
| Erase Lock | 0 | 1 | 0 | 0 | 1 | 1 | 0 | 0 | 0 | 0/1 | 00000 | 0 | | |
| Load Lock(Buffer Lock) | 0 | 1 | 1 | 0 | 0 | 1 | 0 | 0 | 0 | 0/1 | 00000 | 0 | | |
| OTP Program Fail(Lock) | 0 | 1 | 0 | 1 | 0 | 1 | 0 | 0 | 0 | 1 | 00000 | 0 | | |
| OTP Program Fail | 0 | 0 | 0 | 1 | 0 | 1 | 0 | 0 | 0 | 0 | 00000 | 0 | | |
| OTP Erase Fail | 0 | 1 | 0 | 0 | 1 | 1 | 0 | 0 | 0 | 0/1 | 00000 | 0 | | |
| Program Ongo- ing(Susp.) | 1 | 0 | 0 | 1 | 1 | 0 | 1 | 0 | 0 | 0/1 | 00000 | 0 | | |
| Load Ongoing(Susp.) | 1 | 0 | 1 | 0 | 1 | 0 | 1 | 0 | 0 | 0/1 | 00000 | 0 | | |
| Program Fail(Susp.) | 0 | 0 | 0 | 1 | 1 | 1 | 1 | 0 | 0 | 0/1 | 00000 | 0 | | |
| Load Fail(Susp.) | 0 | 0 | 1 | 0 | 1 | 1 | 1 | 0 | 0 | 0/1 | 00000 | 0 | | |
| Invalid Command | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0/1 | 00000 | 0 | | |
| Invalid Com- mand(Susp.) | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 0 | 0 | 0/1 | 00000 | 0 | | |

NOTE:

- 1. ERm and/or ERs bits in ECC status register at Load Fail case is 10. (2bits error uncorrectable)
- 2. ERm and ERs bits in ECC status register at Load Reset case are 00. (No error)
- 3. Multi Block Erase status should be checked by Erase Verify Read operation.
- 4. OTP Erase does not update the register and the previous value is kept.



7.23 Interrupt Status Register (R/W): F241h, default=8080h(after Cold reset),8010h(after Warm/Hot reset)

| Ī | 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|---|-----|-------------------|----|----|----|----|---|---|---|----|----|------|---|---------|----------|---|
| Ī | INT | Reserved(0000000) | | | | | | | | WI | EI | RSTI | | Reserve | ed(0000) | |

| Bit | Bit Name | Defa | ult State | Valid | Function |
|---------|--|------|-----------|--------|-------------------|
| Address | | Cold | Warm/Hot | States | |
| 15 | INT(interrupt): the master interrupt bit | 1 | 1 | 0 | Interrupt Off |
| | - Set to '1' of itself when one or more of RI, WI, EI and RSTI is set to '1', or Unlock(0023h), Lock(002Ah), Locktight(002Ch), or Erase Verify Read(0071h), or OTP access(0065h) operation, or "Load Data into Buffer" is completed. - Cleared to '0' when by writing '0' to this bit or by reset(Cold/Warm/Hot reset). '0' in this bit means that INT pin is low status. (This INT bit is directly wired to the INT pin on the chip. INT pin goes low upon writing '0' to this bit when INTpol is high and goes high upon writing '0' to this bit when INTpol is low.) | | | 0->1 | Interrupt Pending |
| 7 | RI(Read Interrupt): | 1 | 0 | 0 | Interrupt Off |
| | - Set to '1' of itself at the completion of Load Operation (0000h, 0013h, or boot is done.) - Cleared to '0' when by writing '0' to this bit or by reset (Cold/Warm/Hot reset). | | | 0->1 | Interrupt Pending |
| 6 | WI(Write Interrupt): | 0 | 0 | 0 | Interrupt Off |
| | - Set to '1' of itself at the completion of Program Operation (0080h, 001Ah, or 001Bh) - Cleared to '0' when by writing '0' to this bit or by reset (Cold/Warm/Hot reset). | | | 0->1 | Interrupt Pending |
| 5 | EI(Erase Interrupt): | 0 | 0 | 0 | Interrupt Off |
| | - Set to '1' of itself at the completion of Erase Operation (0094h, 0095h, or 0030h) - Cleared to '0' when by writing '0' to this bit or by reset (Cold/Warm/Hot reset). | | | 0->1 | Interrupt Pending |
| 4 | RSTI(Reset Interrupt): | 0 | 1 | 0 | Interrupt Off |
| | - Set to '1' of itself at the completion of Reset Operation (00B0h, 00F0h, 00F3h, or warm reset is released.) - Cleared to '0' when by writing '0' to this bit. | | | 0->1 | Interrupt Pending |

7.24 Start Block Address (R/W): F24Ch, default=0000h

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|--------------------|----|----|----|----|----|---|---|---|---|---|----|----|---|---|---|
| Reserved(00000000) | | | | | | | | | | | SI | BA | | | |

SBA (Lock/Unlock/Lock-tight Start Block Address): Start NAND Flash block address in Write Protection mode, which follows 'Lock block command' or 'Unlock block command' or 'Lock-tight command'.

7.25 End Block Address (R/W): F24Dh, default=0000h

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|----|----|----------|---------|-----|---|---|---|---|---|---|----|---|---|---|
| | | Re | eserved(| 0000000 | 00) | | | | | | | BA | | | |

EBA (Lock/Unlock/Lock-tight End Block Address): End NAND Flash block address in Write Protection mode, which follows 'Lock block command' or 'Unlock block command' or 'Lock-tight command'. EBA should be equal to or larger than SBA.

| Device | Number of Block | SBA/EBA |
|--------|-----------------|---------|
| 128Mb | 256 | [7:0] |



7.26 NAND Flash Write Protection Status (R): F24Eh, default=0002h

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|------------------------|----|----|----|----|---|---|---|----|----|-----|---|---|---|---|
| | Reserved(000000000000) | | | | | | | | US | LS | LTS | | | | |

US (Unlocked Status): '1' value of this bit specifies that the current block in NAND Flash is unlocked.

LS (Locked Status): '1' value of this bit specifies that the current block in NAND Flash is in locked status.

LTS (Lock-tighten Status): '1' value of this bit specifies that current block in NAND Flash is lock-tighten.

7.27 ECC Status Register(R): FF00h, default=0000h

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|--------------------|----|----|----|----|---|---|----|----|----|-----|----|-----|----|-----|
| | Reserved(00000000) | | | | | | | ER | m1 | EF | Rs1 | ER | Rm0 | ER | Rs0 |

ERm (ECC Error for Main area data) & ERs (ECC Error for Spare area data)

: ERm0/1 is for first/second selected sector in main of BufferRAM, ERs0/1 is for first/second selected sector in spare of BufferRAM.

ERm and ERs show the number of error nits in a sector as a result of ECC check at the load operation.

| ERm, ERs | ECC Status |
|----------|------------------------------|
| 00 | No Error |
| 01 | 1-bit error(correctable) |
| 10 | 2-bit error(uncorrectable)1) |
| 11 | Reserved |

NOTE

1. 3bits or more error detection is not supported.

7.28 ECC Result of first selected Sector Main area data Register (R): FF01h, default=0000h

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|---------|----------|----|----------------|----|---|---|---|---|---|---|------|-------|---|---|
| | Reserve | ed(0000) | | ECCposWord0 EC | | | | | | | | ECCp | oslO0 | | |

7.29 ECC Result of first selected Sector Spare area data Register (R): FF02h, default=0000h

| | | | | | | | | • | | | | • | | | |
|----|----|----|-----|---------|--------|------|---|---|---|---------------|---|---|-----|-------|---|
| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| | | | Res | erved(0 | 000000 | 000) | | | | ECClogSector0 | | | ECC | oslO0 | |

7.30 ECC Result of second selected Sector Main area data Register (R): FF03h, default=0000h

| 4.5 | 4.4 | 40 | 40 | 44 | 11 10 9 8 7 6 5 4 | | | | | | | | _ | 4 | ^ |
|-----|---------|----------|----|-----------------------|-------------------|---|---|---|---|---|---|---|---|---|---|
| 15 | 14 | 13 | 12 | 11 | 10 | 9 | ð | ′ | ь | 5 | 4 | 3 | 2 | 1 | U |
| | Reserve | ed(0000) | , | ECCposWord1 ECCposIO1 | | | | | | | | | | | |

7.31 ECC Result of second selected Sector Spare area data Register (R): FF04h, default=0000h

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|----|----|-----|---------|--------|------|---|---|---|---------------|---|---|-----|-------|---|
| | | | Res | erved(0 | 000000 | 000) | | | | ECClogSector1 | | | ECC | oslO1 | |

NOTE

- 1. ECCposWord: ECC error position address that selects one of Main area data(256words)
- 2. ECCposIO: ECC error position address which selects one of sixteen DQs (DQ 0~DQ 15).
- 3. ECClogSector: ECC error position address that selects one of the 2nd word and LSB of the 3rd word of spare area. Refer to the below table.

ECClogSector Information [5:4]

| ECClogSector | Error Position |
|--------------|----------------|
| 00 | 2nd word |
| 01 | 3rd word |
| 10, 11 | Reserved |

4. ECCposWord, ECCposIO and ECClogSector are updated in boot loading operation, too.



8. Device Operation

The device supports both a limited command based and a register based interface for performing operations on the device, reading device ID, writing data to buffer etc. The command based interface is active in the boot partition, i.e. commands can only be written with a boot area address. Boot area data is only returned if no command has been issued prior to the read.

8.1 Command based operation

The entire address range, except for the boot area, can be used for the data buffer. All commands are written to the boot partition. Writes outside the boot partition are treated as normal writes to the buffers or registers. The command consists of one or more cycles depending on the command. After completion of the command the device starts its execution. Writing incorrect information which include address and data or writing an improper command will terminate the previous command sequence and make the device go to the ready status. The defined valid command sequences are stated in Table4.

Table 4. Command Sequences

| Command Definition | | Cycles | 1st cycle | 2nd cycle |
|--|------|--------|------------------|---------------------|
| Read Data from Buffer | Add | 1 | DP ¹⁾ | |
| | Data | 1 | Data | |
| Write Data to Buffer | Add | 1 | DP | |
| | Data | 1 | Data | |
| Reset OneNAND | Add | 1 | BP ²⁾ | |
| | Data | 1 | 00F0h | |
| Load Data into Buffer³) | Add | 2 | BP | BP |
| | Data | 2 | 00E0h | 0000h ⁴⁾ |
| Read Identification Data ⁶⁾ | Add | 2 | BP | XXXXh ⁵⁾ |
| | Data | | 0090h | Data |

NOTE:

- 1) DP(Data Partition) : DataRAM Area
- 2) BP(Boot Partition): BootRAM Area [0000h ~ 01FFh, 8000h ~ 800Fh].
- 3) Load Data into Buffer operation is available within a block(64KB)
- 4) Load 1KB unit into DataRAM0. Current Start address(FPA) is automatically incremented by 1KB unit after the load.
- 5) 0000h -> Data is Manufacturer ID
- 0001h -> Data is Device ID
- 0002h -> Current Block Write Protection Status
- 6) WE toggling can terminate 'Read Identification Data' operation.

8.1.1 Read Data from Buffer

Buffer can be read by addressing a read to a wanted buffer area

8.1.2 Write Data to Buffer

Buffer can be written by addressing a write to a wanted buffer area

8.1.3 Reset OneNAND

Reset command is given by writing 00F0h to the boot partition address. Reset will return all default values into the device.

8.1.4 Load Data into Buffer

Load Data into Buffer command is a two-cycle command. Two sequential designated command activates this operation. Sequentially writing 00E0h and 0000h to the boot partition [0000h~01FFh, 8000h~800Fh] will load one page to DataRAM0. This operation refers to FBA and FPA. FSA, BSA, and BSC are not considered.

At the end of this operation, FPA will be automatically increased by 1. So continuous issue of this command will sequentially load data in next page to DataRAM0. This page address increment is restricted within a block.

The default value of FBA and FPA is 0. Therefore, initial issue of this command after power on will load the first page of memory, which is usually boot

8.1.5 Read Identification Data

Read Identification Data command consists of two cycles. It gives out the devices identification data according to the given address. The first cycle is 0090h to the boot partition address and second cycle is read from the addresses specified in Table5.



Table 5. Identification data description

| Address | Data Out | | | | | |
|---------|---------------------------------------|--|--|--|--|--|
| 0000h | Manufacturer ID | 00ECh | | | | |
| 0001h | Device ID | refer to table 1 | | | | |
| 0002h | Current Block Write Protection Status | refer to NAND Flash Write Protection Status Register | | | | |

8.2 Device Bus Operations

| Operation | CE | ŌĒ | WE | ADD0~15 | DQ0~15 | RP | CLK | AVD |
|---|----|----|----|---------|-------------------|----|-----|-----|
| Standby | Н | Х | Х | Х | High-Z | Η | Х | Х |
| Warm Reset | Х | Х | Х | Х | High-Z | L | Х | Х |
| Asynchronous Write | L | Н | L | Add. In | Data In | Н | L | |
| Asynchronous Read | L | L | н | Add. In | Data Out | н | L | |
| Load Initial Burst Address | L | Н | Н | Add. In | Х | Н | | |
| Burst Read | L | L | Н | х | Burst Data Out | Н | | х |
| Terminate Burst Read Cycle | Н | Х | Н | Х | High-Z | Н | Х | х |
| Terminate Burst Read Cycle via RP | Х | Х | Х | Х | High-Z | L | Х | х |
| Terminate Current Burst Read Cycle and Start New Burst Read Cycle | | Н | Н | Add In | High-Z | Н | | |

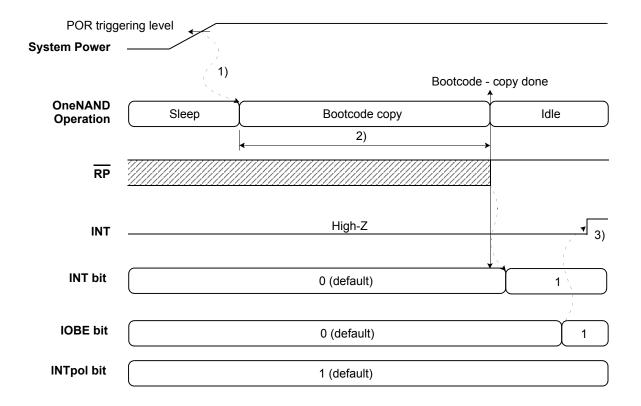
Note : L=V_{IL} (Low), H=V_{IH} (High), X=Don't Care.



8.3 Reset Mode

Cold Reset

At system power-up, the voltage detector in the device detects the rising edge of Vcc and releases internal power-up reset signal which triggers bootcode loading. Bootcode loading means that the boot loader in the device copies designated sized data(1KB) from the beginning of memory to the BootRAM.



Note: 1) Bootcode copy operation starts 400us later than POR activation.

The system power should reach 1.7V after POR triggering level(typ. 1.5V) within 400us for valid boot code data.

- 2) 1K bytes Bootcode copy takes 70us(estimated) from sector0 and sector1/page0/block0 of NAND Flash array to BootRAM. Host can read Bootcode in BootRAM(1K bytes) after Bootcode copy completion.
- 3) INT register goes 'Low' to 'High' on the condition of 'Bootcode-copy done' and RP rising edge.

 If RP goes 'Low' to 'High' before 'Bootcode-copy done', INT register goes to 'Low' to 'High' as soon as 'Bootcode-copy done'

Figure 5. Cold Reset Timings



Warm Reset

Warm reset means that the host resets the device by \overline{RP} pin, and then the device stops all logic current operation and executes internal reset operation(Note 1) synchronized with the falling edge of \overline{RP} and resets current NAND Flash core operation synchronized with the rising edge of \overline{RP} . The device logic will not be reset in case \overline{RP} pulses shorter than 200ns, but the device guarantees the logic reset operation in case \overline{RP} pulse is longer than 200ns. NAND Flash core reset will abort current NAND Flash Core operation. The contents of memory cells being altered are no longer valid as the data will be partially programmed or erased. Warm reset has no effect on contents of BootRAM and DataRAM.

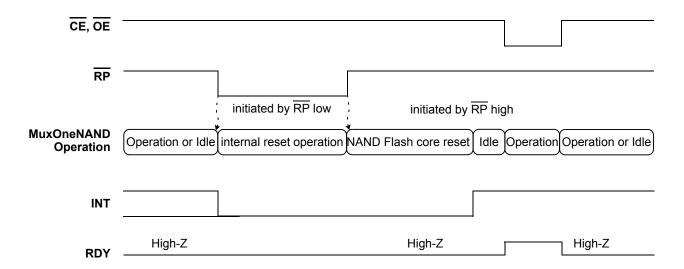


Figure 6. Warm Reset Timings



Hot Reset

Hot reset means that the host resets the device by reset command(Note 2), and then the device logic stops all current operation and executes internal reset operation(Note 1), and resets current NAND Flash core operation. Hot reset has no effect on contents of BootRAM and DataRAM.

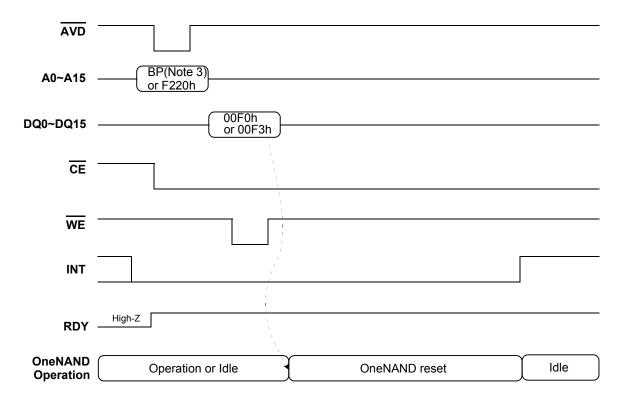


Figure 7. Hot Reset Timings

NOTE:

- 1. Internal reset operation means that the device initializes internal registers and makes output signals go to default status and bufferRAM data are kept unchanged after Warm/Hot reset operations.
- Reset command : Command based reset or Register based reset
- 3. BP(Boot Partition): BootRAM area[0000h~01FFh, 8000h~800Fh]

NAND Flash Core Reset

Host can reset NAND Flash Core operation by NAND Flash Core reset command. NAND Flash Core Reset will abort the current NAND Flash core operation. During a NAND Flash Core Reset, the content of memory cells being altered is no longer valid as the data will be partially programmed or erased. NAND Flash Core Reset has an effect on neither contents of BootRAM and DataRAM nor register values.

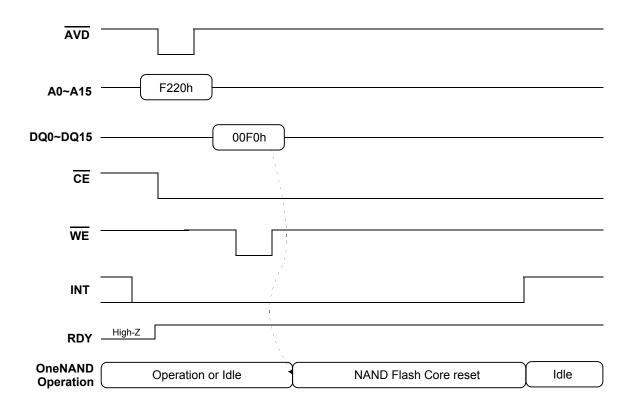


Figure 8. NAND Flash Core Reset Timings

Table 6. Internal Register reset

| | Internal Registers | Default | Cold Reset | Warm Reset (RP) | Hot Reset (00F3h) | Hot Reset (BP-F0) | NAND Flash Reset(00F0h) |
|-------|---|---------|------------|--------------------|-------------------------|-------------------------|----------------------------|
| F000h | Manufacturer ID Register (R) | 00ECh | N/A | N/A | N | /A | N/A |
| F001h | Device ID Register (R) | Note3 | N/A | N/A | N | /A | N/A |
| F002h | Version ID Register (rR) | - | N/A | N/A | N | /A | N/A |
| F003h | Data Buffer size Register (R) | 0400h | N/A | N/A | N | /A | N/A |
| F004h | Boot Buffer size Register (R) | 0200h | N/A | N/A | N | /A | N/A |
| F005h | Amount of Buffers Register (R) | 0201h | N/A | N/A | N | /A | N/A |
| F006h | Technology Register (R) | 0000h | N/A | N/A | N | /A | N/A |
| F100h | Start Address1 Register (R/W): FBA | 0000h | 0000h | 0000h | 000 | 00h | N/A |
| F101h | Start Address2 Register (R/W): Reserved | 0000h | 0000h | 0000h | 000 | 00h | N/A |
| F102h | Start Address3 Register (R/W): FCBA | 0000h | 0000h | 0000h | 0000h | | N/A |
| F103h | Start Address4 Register (R/W): FCPA, FCSA | 0000h | 0000h | 0000h | 000 | 00h | N/A |
| F107h | Start Address8 Register (R/W): FPA, FSA | 0000h | 0000h | 0000h | 000 | 00h | N/A |
| F200h | Start Buffer Register (R/W): BSA, BSC | 0000h | 0000h | 0000h | 000 | 00h | N/A |
| F220h | Command Register (R/W) | 0000h | 0000h | 0000h | 000 | 00h | N/A |
| F221h | System Configuration 1 Register (R/W) | 40C0h | 40C0h | O (Note1) | O (N | ote1) | N/A |
| F240h | Controller Status Register (R) | 0000h | 0000h | 0000h | 000 | 00h | N/A |
| F241h | Interrupt Status Register (R/W) | - | 8080h | 8010h | 80 | 10h | N/A |
| F24Ch | Lock/Unlock Start Block Address (R/W) | 0000h | 0000h | 0000h | N | /A | N/A |
| F24Dh | Lock/Unlock End Block Address (R/W) | 0000h | 0000h | 0000h | N. | /A | N/A |
| F24Eh | NAND Flash Write Protection Status (R) | 0002h | 0002h | 0002h | N | /A | N/A |
| FF00h | ECC Status Register (R) (Note2) | 0000h | 0000h | 0000h | 000 | 00h | N/A |
| FF01h | ECC Result of Sector 0 Main area data Register(R) | 0000h | 0000h | 0000h | 0000h | | N/A |
| FF02h | ECC Result of Sector 0 Spare area data Register (R) | 0000h | 0000h | 0000h | 0000h | | N/A |
| FF03h | ECC Result of Sector 1 Main area data Register(R) | 0000h | 0000h | 0000h | 000 | 00h | N/A |
| FF04h | ECC Result of Sector 1 Spare area data Register (R) | 0000h | 0000h | 0000h | 000 | 00h | N/A |

NOTE: 1) RDYpol, INTpol, and IOBE are reset by Cold reset. The other bits are reset by Cold/Warm/Hot reset.



OTPL is not reset but updated by Cold reset.

2) ECC Status Register & ECC Result Registers are reset when any command is issued.

³⁾ Refer to table 1

Write Protection

Write Protection for BootRAM

At system power-up, the voltage detector in the device detects the rising edge of Vcc and releases the internal power-up reset signal which triggers bootcode loading. And the designated size data(1KB) is copied from the beginning of the memory to the BootRAM. After the bootcode loading is completed, the BootRAM is always locked to protect the significant boot code from accidental write.

Write Protection for NAND Flash array

Write Protection Modes

The device offers both hardware and software write protection features for NAND Flash array. The software write protection feature is used by writing Lock command or Lock-tight command to command register; The 002Ah or 002Ch command is written into F220h register. The partial write protection feature is also permitted by writing Partial Lock(002Ah) and Partial Lock-Tight(002Ch) command with the start address and the end address to F24Ch and F24Dh registers. The hardware write protection feature is used by executing cold or warm reset. The default state is locked, and all NAND Flash array goes to locked state after cold or warm reset.

Write Protection Commands

Individual or consecutive instant secured block protects code and data by allowing any block to be locked or lock-tighten. The write protection scheme offers two levels of protection. The first allows software-only control of write protection(useful for frequently changed data blocks), while the second requires hardware interaction before locking can be changed(protects infrequently changed code blocks).

The following summarize the locking functionality.

- > All blocks power-up in a locked state. Unlock command can unlock these blocks with the start and end block address.
- > Partial Lock-Tight command makes the part of locked block(s) to be lock-tightened by writing the start and end block address. And lock-tightened state can be returned to lock state only when cold or warm reset is asserted.
- > Only one individual area can be lock-tightened by Partial Lock-tight command; i.e lock-tightening multi area is not available.
- > Lock-tightened blocks offer the user an additional level of write protection beyond that of a regular locked block. Lock-tightened block can't have it's state changed by software, it can be changed by warm reset or cold reset.
- > Unlock start or end block address is reflected immediately to the device only when Unlock command is issued, and NAND Flash write protection status register is also updated at that time.
- > Unlocked blocks can be programmed or erased.
- > Only one area can be released from lock state to unlock state with Unlock command and addresses. This unlocked area can be changed with new Unlock command; when new Unlock command is issued, last unlocked area is locked again and new area is unlocked.
- > Partial Lock command makes the part of unlocked block(s) to be locked with the start and end block address.
- > Only one area can be locked with Partial Lock command and address. This locked area can be changed with new Partial Lock command; when new Partial Lock command is issued, last unlocked area is locked again and new area is unlocked.

Write Protection Status

The block current Write Protection status can be read in NAND Flash Write Protection Status Register(F24Eh). There are three bits - US, LS, LTS -, which are not cleared by hot reset. These Write Protection status registers are updated when Write Protection command is entered.

The followings summarize locking status.

example)

In default, [2:0] values are 010.

- -> If host executes unlock block operation, then [2:0] values turn to 100.
- -> If host executes lock-tight block operation, then [2:0] values turn to 001.



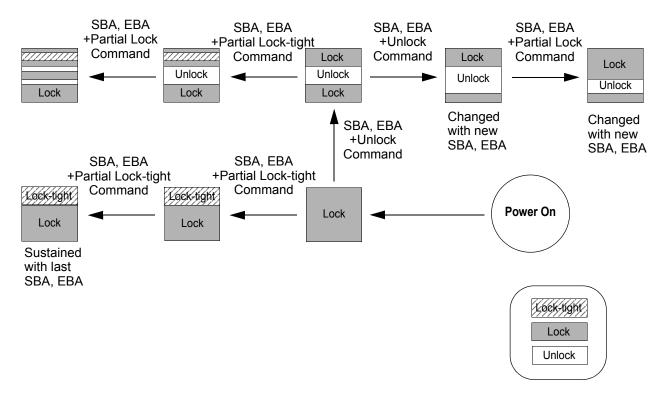
Locked > Command Sequence: Start block address+End block address+Lock block command (002Ah) > All blocks default to be locked after Cold reset or Warm reset > Unlocked blocks can be locked by using the Lock block command and a lock block's status can be changed to unlock or lock-tight using the appropriate software commands Unlocked > Command Sequence : Start block address+End block address+Unlock block command (0023h) > Unlocked block can be programmed or erased > An unlocked block's status can be changed to the locked or lock-tighten state using the appropriate software command > Only one sequential area can be released to unlock state from lock state; Unlocking multi individual area is not available

Lock-tighten

- > Command Sequence :
- Start block address+End block address+Lock-tight block command (002Ch)
- Lock-tighten blocks offer the user an additional level of write protection beyond that of a regular lock block. A block that is lock-tighten cannot have its state change by software, only by Cold or Warm reset.
- > Only locked blocks can be lock-tighten by Lock-tight command.
- > Lock-tighten blocks revert to the locked state at Cold or Warm reset
- > Lock-tighten area does not change with any command; when new unlock command is issued including the lock-tighten area, new unlocked command is ignored.

Figure 9. Operations of NAND Flash Write Protection





Note; The below cases are prohibited in write protection modes.

Even though these cases happen, Error bit of Controller Status Register(F240h)is not updated.

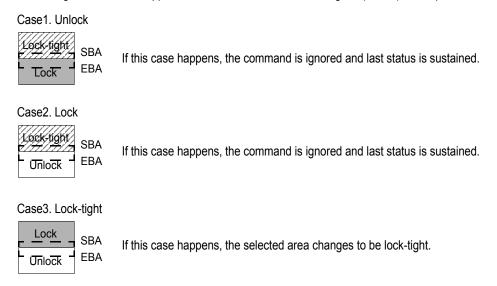


Figure 10. State diagram of NAND Flash Write Protection



Load Operation

The load operation is initiated by setting up the start address from which the data is to be loaded. The load command is issued in order to initiate the load. The device transfers the data from NAND Flash array into the BufferRAM. The ECC is checked and any detected and corrected error is reported in the status response as well as any unrecoverable error. When the BufferRAM has been filled an interrupt is issued to the host in order to read the contents of the BufferRAM. The read from the BufferRAM consist of asynchronous read mode or synchronous read mode. The status information related to the BufferRAM fill operation can be checked by the host if required.

The device provides dual data buffer memory architecture. The device is capable of data-read operation from one data buffer and data-load operation to the other data buffer simultaneously. Refer to the information for more details in "Read while Load operation".

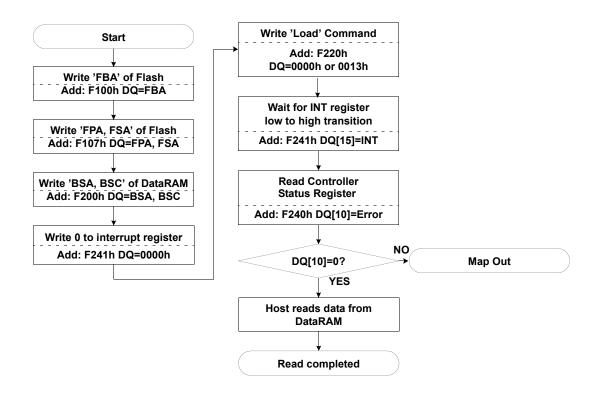


Figure 11. Load operation flow-chart



Read Operation

The device has two read configurations; Asynchronous read and Synchronous burst read.

The initial state machine makes the device to be automatically entered into asynchronous read mode to prevent the memory content from spurious altering upon device power up or after a hardware reset. No commands are required to retrieve data in asynchronous mode. The synchronous mode will be enabled by setting RM bit of System configuration1 register to Synchronous read mode.

Asynchronous Read Mode (RM = 0)

For the asynchronous read mode a valid address should be asserted on A0-A15, while driving $\overline{\text{AVD}}$ and $\overline{\text{CE}}$ to Vil. $\overline{\text{WE}}$ should remain at Vih . The data will appear on DQ15-DQ0. Address access time (tAA) is equal to the delay from valid addresses to valid output data. The chip enable access time(tCE) is the delay from the falling edge of $\overline{\text{CE}}$ to valid data at the outputs. The output enable access time(tOE) is the delay from the falling edge of $\overline{\text{OE}}$ to valid data at the output.

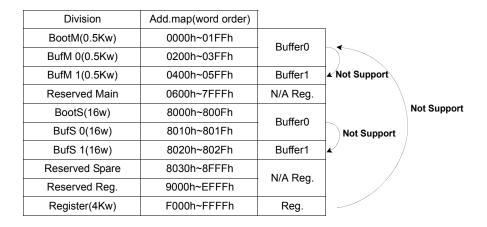
Synchronous (Burst) Read Mode (RM = 1)

The device is capable of continuous linear burst operation and linear burst operation of a preset length. For the burst mode, the initial word(tIAA) is output asynchronously regardless of BRL bit in System Configuration 1 register. But the host should determine BRL bit of System configuration 1 register for the subsequent words of each burst access. The registers also can be read during burst read mode by using $\overline{\text{AVD}}$ signal with a address. To initiate the synchronous read again, a new address during $\overline{\text{CE}}$ and $\overline{\text{AVD}}$ low toggle is needed after the host has completed status reads or the device has completed the program or erase operation.

Continuous Linear Burst Read

The initial word(tiAA) is output asynchronously regardless of BRL bit in System Configuration 1 register. Subsequent words are output tbA after the rising edge of each successive clock cycle, which automatically increments the internal address counter. The RDY output indicates this condition to the system by pulsing low. The device will continue to output sequential burst data, wrapping around after it reaches the designated location(See Figure 12 for address map information) until the system asserts \overline{CE} high, \overline{RP} low or \overline{AVD} low in conjunction with a new address. The cold/warm/hot reset or asserting \overline{CE} high or \overline{WE} low pulse terminate the burst read operation.

If the device is accessed synchronously while it is set to asynchronous read mode, it is possible to read out the first data without problems.



^{*} Reserved area is not available on Synchronous read

Figure 12. The boundary of synchronous read



4-, 8-,16-, 32- Word Linear Burst Read

As well as the Continuous Linear Burst Mode, there are four(4 & 8 & 16 & 32 word) (Note1) linear wrap-around mode, in which a fixed number of words are read from consecutive addresses. When the last word in the burst mode is reached, assert /CE and /OE high to terminate the operation. In these modes, the start address for burst read can be any address of address map.

(Note 1) 32 word linear burst read isn't available on spare area BufferRAM

Table 7. Burst Address Sequences

| | Start | Burst Address Sequence(Decimal) | | | | | | | | |
|--------|-------|---------------------------------|--------------|-------------------|---------------------|---------------------|--|--|--|--|
| | Addr. | Continuous Burst | 4-word Burst | 8-word Burst | 16-word Burst | 32-word Burst | | | | |
| | 0 | 0-1-2-3-4-5-6 | 0-1-2-3-0 | 0-1-2-3-4-5-6-7-0 | 0-1-2-3-413-14-15-0 | 0-1-2-3-429-30-31-0 | | | | |
| Wrap | 1 | 1-2-3-4-5-6-7 | 1-2-3-0-1 | 1-2-3-4-5-6-7-0-1 | 1-2-3-4-514-15-0-1 | 1-2-3-4-530-31-0-1 | | | | |
| around | 2 | 2-3-4-5-6-7-8 | 2-3-0-1-2 | 2-3-4-5-6-7-0-1-2 | 2-3-4-5-615-0-1-2 | 2-3-4-5-631-0-1-2 | | | | |
| | | | • | | | • | | | | |
| | | • | • | | - | • | | | | |

Programmable Burst Read Latency

The programmable burst read latency feature indicates to the device the number of additional clock cycles that must elapse after $\overline{\text{AVD}}$ is driven active before data will be available. Upon power up, the number of total initial access cycles defaults to four clocks. The number of total initial access cycles is programmable from three to seven cycles.

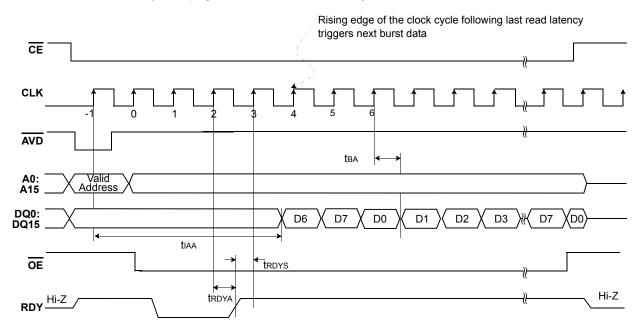


Figure 13. Example of 4 clock Burst Read Latency

Handshaking

The handshaking feature allows the host system to simply monitor the RDY signal from the device to determine when the initial word of burst data is ready to be read. To set the number of initial cycle for optimal burst mode, the host should use the programmable burst read latency configuration.(See "System Configuration1 Register" for details.) The rising edge of RDY which is derived from 1 clock ahead of data fetch clock indicates the initial word of valid burst data.

Output Disable Mode

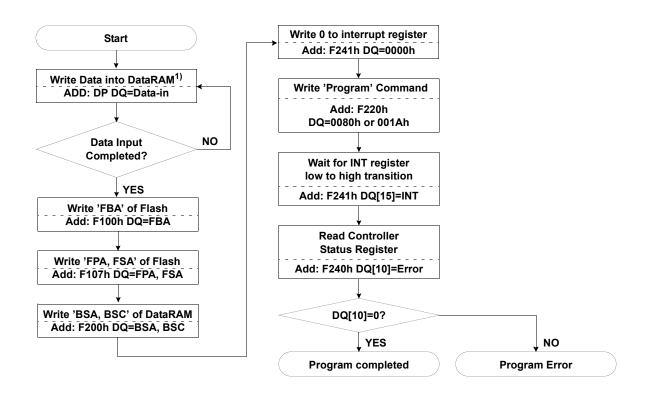
When the $\overline{\text{CE}}$ or $\overline{\text{OE}}$ input is at V_{IH}, output from the device is disabled. The outputs are placed in the high impedance state.



Program Operation

The device can be programmed in data unit. Programming is writing 0's into the memory array by executing the internal program routine. In order to perform the Internal Program Routine, command sequence is necessary. First, host sets the address of the Buffer-RAM and the memory location and loads the data to be programmed into the Buffer-RAM. Second, program command initiates the internal program routine. During the execution of the Routine, the host is not required to provide further controls or timings. During the Internal Program Routine, commands except reset command written to the device will be ignored. Note that a reset during a program operation will cause data corruption at the corresponding location.

The device provides dual data buffer memory architecture. The device is capable of data-write operation from host to one of data buffers during program operation from anther data buffer to Flash simultaneously. Refer to the information for more details in "Read while Load operation".



* : If program operation results in an error, map out the block including the page in error and copy the target data to another block.

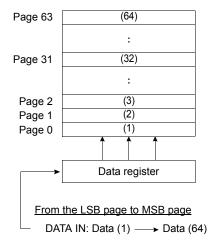
Note 1) Data input could be done anywhere between "Start" and "Write Program Command".

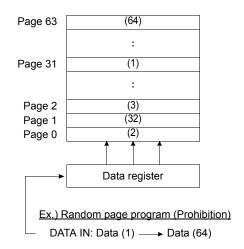
Figure 14. Program operation flow-chart



Addressing for program operation

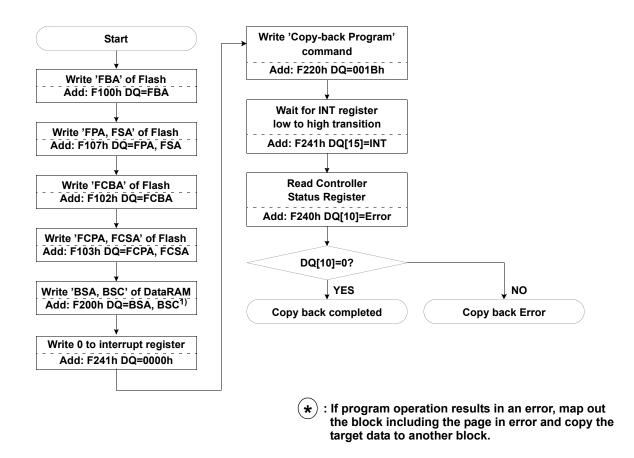
Within a block, the pages must be programmed consecutively from the LSB (least significant bit) page of the block to MSB (most significant bit) pages of the block. Random page address programming is prohibited.





Copy-back Program Operation

The copy-back program is configured to quickly and efficiently rewrite data stored in one page by sector unit(1/2 sector) without utilizing an external memory. Since the time-consuming cycles of serial access and re-loading cycles are removed, the system performance is improved. The benefit is especially obvious when a portion of a block is updated and the rest of the block also need to be copied to the newly assigned free block. The operation for performing a copy-back program is a sequential execution of page-read without serial access and copying-program with the address of destination page.



Note 1) Selected DataRAM by BSA & BSC is used for Copy back operation, so previous data is overwritten.

Figure 15. Copy back program operation flow-chart



Copy-Back Program Operation with Random Data Input

The Copy-Back Program Operation with Random Data Input in OneNAND consists of 2 phase, Load data into DataRAM, Modify data and program into designated page. Data from the source page is saved in one of the on-chip DataRAM buffers and modified by the host, then programmed into the destination page.

As shown in the flow chart, data modification is possible upon completion of load operation. ECC is also available at the end of load operation. Therefore, using hardware ECC of OneNAND, accumulation of 1 bit error can be avoided.

Copy-Back Program Operation with Random Data Input will be effectively utilized at modifying certain bit, byte, word, or sector of source page to destination page while it is being copied.

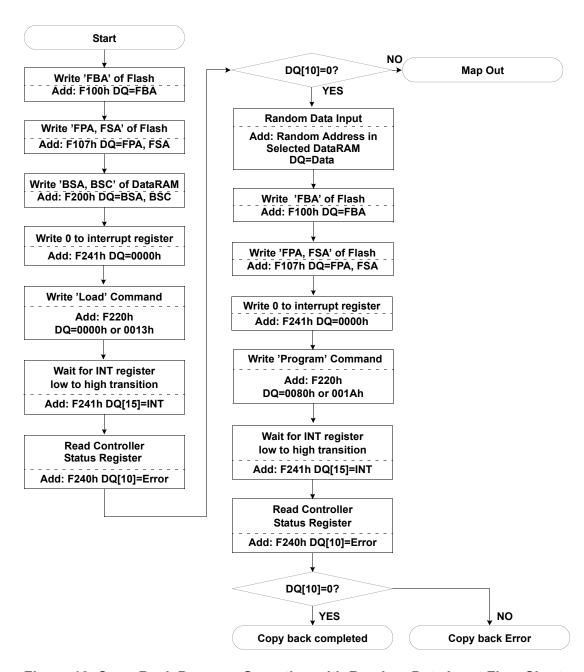


Figure 16. Copy-Back Program Operation with Random Data Input Flow Chart



Erase Operation

The device can be erased in block unit. To erase a block is to write 1's into the desired memory block by executing the Internal Erase Routine. In order to perform the Internal Erase Routine, command sequence is necessary. First, host sets the block address of the memory location. Second, erase command initiates the internal erase routine. During the execution of the Routine, the host is not required to provide further controls or timings.

During the Internal erase routine, commands except reset and erase suspend command written to the device will be ignored. Note that a reset during a erase operation will cause data corruption at the corresponding location.

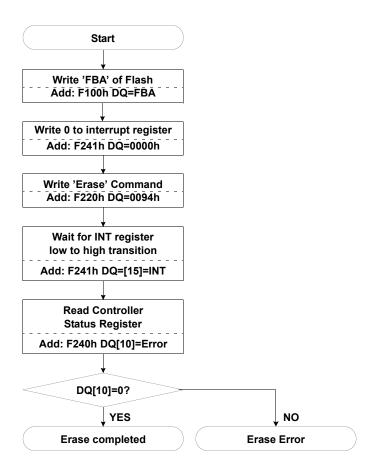


Figure 17. Erase operation flow-chart



Multi Block Erase and Multi Block Erase Verify Read Operation

The device can be simultaneously erased in multi blocks unit, too. The block address of the memory location and Multi Block Erase command may be repeated for erasing multi blocks. The final block address and Block Erase command initiate the internal multi block erase routine. During Multi Block Erase routine, if the command except Multi Block Erase command is written before Block Erase command is issued, Multi Block Erase operation will be aborted. Erase Suspend command is allowed only when INT is Low after Block Erase command is issued.

Pass/fail status of each block in Multi Block Erase operation can be read by writing each block address and Multi Block Erase Verify Read command. But the information of the failed address has to be managed by the firmware. After Block Erase operation, the pass/fail status can be read with Multi Block Erase Verify Read command, too.

Note that a reset during a erase operation will cause data corruption at the corresponding location.

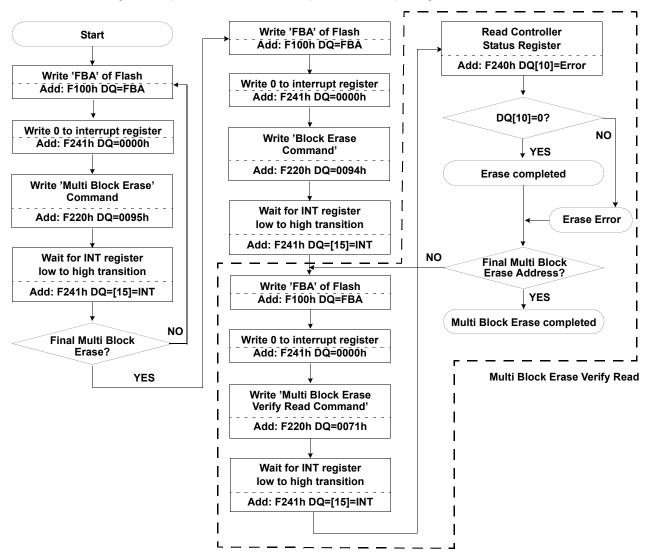


Figure 18. Multi Block Erase operation flow-chart

NOTE:

1. If there are the locked blocks in the specified range, the operation works as the follows.

Case 1. [BA(1)+0095h] + [BA(2, locked)+0095h] + ... + [BA(N-1)+0095h] + [BA(N)+0094h] = All specified blocks except BA(2) are erased.

Case 2. [BA(1)+0095h] + [BA(2)+0095h] + ... + [BA(N-1)+0095h] + [BA(N, locked)+0094h] = If the last command, Block Erase command, is put together with the locked block address, Multi Block Erase operation doesn't start and is suspended until right command and address input.

Case 3. [BA(1)+0095h] + [BA(2)+0095h] + ... + [BA(N-1)+0095h] + [BA(N, locked)+0094h] + [BA(N+1)+0094h] = All specified blocks except BA(N) are erased.

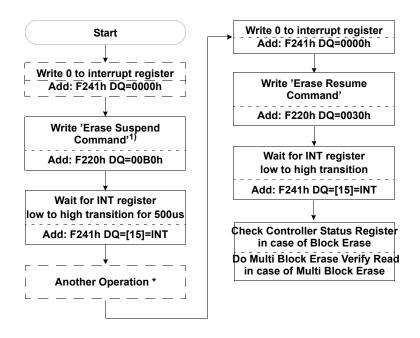
- 2. The OnGo bit of Controller Status register is set to '1'(busy) from the time of writing the 1st block address to be latched until the actual erase has finished
- 3. Even though the failed blocked happen during multi block erase operation, the device continues the erase operation until other specified blocks are erased.



Erase Suspend / Resume

Erase Suspend command interrupts Block Erase and Multi Block Erase to load or program data in a block that is not being erased. When Erase Suspend command is written during Block Erase and Multi Block Erase operation, the device requires a maximum of 500us to suspend erase operation. After the erase operation has been suspended, the device is available for loading or programming data in a block that is not being erased. For the erase suspend period, Block Erase, Multi Block Erase and Erase Suspend commands are not accepted.

When Erase Resume command is executed, Block Erase and Multi Block Erase operation will resume. The Erase Resume operation does not actually resume the erase, but starts it again from the beginning. When Erase Suspend and Erase Resume command is executed, the addresses are in Don't Care state.



* Another Operation; Load, Program Copy-back Program, OTP Access²⁾, Hot Reset, Flash Reset, CMD Reset, Multi Block Erase Verify, Lock, Lock-tight, Unlock

Note 1) Erase Suspend command input is prohibited during Multi Block Erase address latch period.

2) If OTP access mode exit happens with Reset operation during Erase Suspend mode,
Reset operation could hurt the erase operation. So if a user wants to exit from OTP access mode
without the erase operation stop, Reset NAND Flash Core command should be used.

Figure 19. Erase Suspend and Resume operation flow-chart



OTP Operation

The device supports one block sized OTP area, which can be read, programmed and locked with the same sequence as normal operation. But this OTP block could not be erased. This block is separated from NAND Flash Array, so it could be accessed by OTP Access command instead of FBA. If user wants to exit from OTP access mode, Cold, Warm and Hot Reset operation should be done. But if OTP access mode exit happens with Reset operation during Erase Suspend mode, Reset operation could hurt the erase operation. So if user wants to exit from OTP access mode without the erase operation stop, 'Reset NAND Flash Core' command should be used.

OTP area is one block size(64KB, 64pages) and is divided by two areas. The first area from page 0 to page 19, total 20pages, is assigned for user and the second area from page 20 to page 63, total 44pages, are occupied for the device manufacturer. The second area is programmed prior to shipping, so this area could not be used by user. This block is fully guaranteed to be a valid block.

OTP Block Page Allocation Information

| Area | Page | Use |
|--------------|--------------------|---------------------------------|
| User | 0 ~ 19 (20 pages) | Designated as user area |
| Manufacturer | 20 ~ 63 (44 pages) | Used by the device manufacturer |

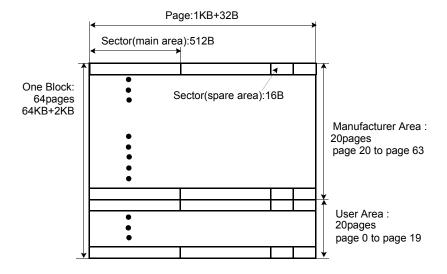
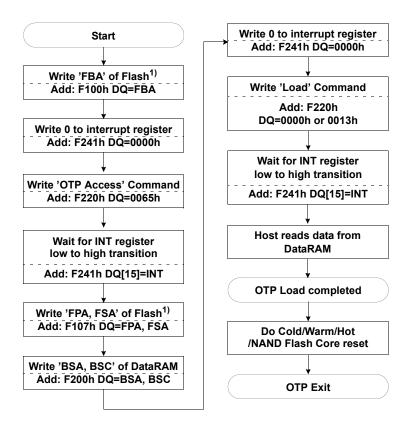


Figure 20. OTP area structure and assignment



OTP Load(OTP Access+Load NAND)

OTP area is separated from NAND Flash Array, so it is accessed by OTP Access command instead of FBA. The content of OTP could be loaded with the same sequence as normal load operation after being accessed by the command. If user wants to exit from OTP access mode, Cold, Warm, Hot, and NAND Flash Core Reset operation should be done.



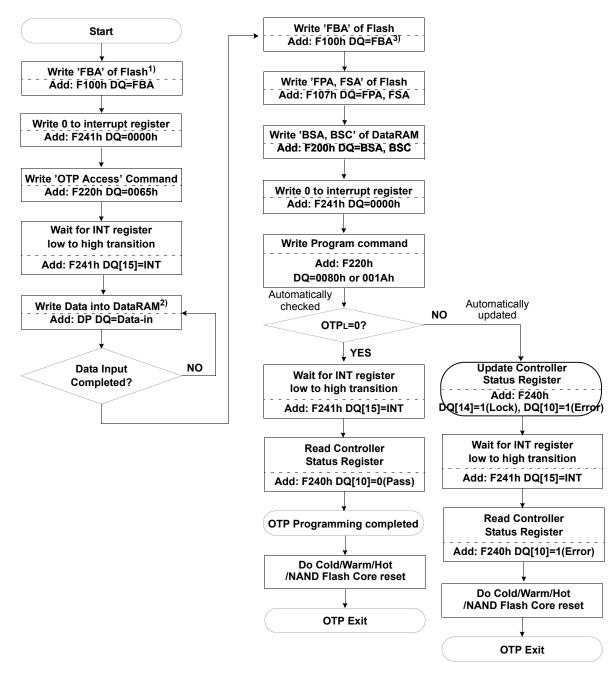
Note 1) FBA(NAND Flash Block Address) could be omitted or any address.

Figure 21. OTP Load operation flow-chart



OTP Programming(OTP Access+Program NAND)

OTP area could be programmed with the same sequence as normal program operation after being accessed by the command. To avoid the accidental write, FBA should point the unlocked area address among NAND Flash Array address map even though OTP area is separated from NAND Flash Array.



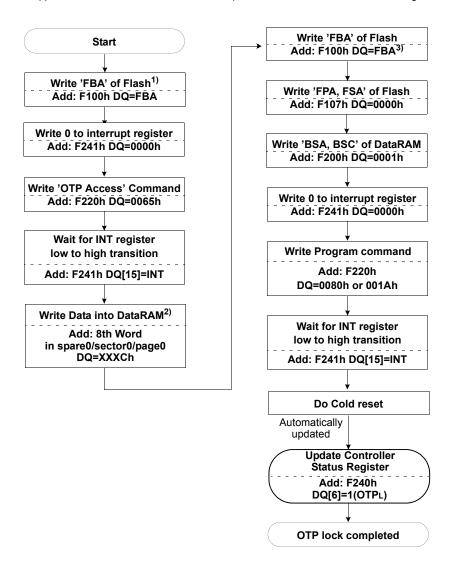
- Note 1) FBA(NAND Flash Block Address) could be omitted or any address.
 - 2) Data input could be done anywhere between "Start" and "Write Program Command".
 - 3) FBA should point the unlocked area address among NAND Flash Array address map.

Figure 22. OTP program operation flow-chart



OTP Lock(OTP Access+Lock OTP)

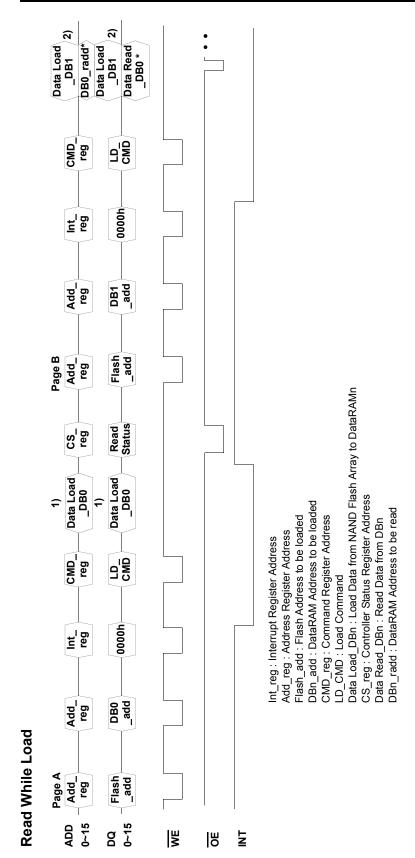
OTP area could be locked by programming XXXCh to 8th word in sector0 of page0 to prevent the program operation. At the device power-up, the device automatically checks this word and updates OTP_L bit of Controller Status register as "1"(lock). If the program operation happens in OTP locked status, the device updates Error bit of Controller Status register as "1"(fail).



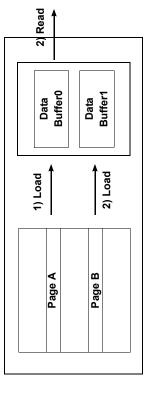
- Note 1) FBA(NAND Flash Block Address) could be omitted or any address.
 - 2) Data input could be done anywhere between "Start" and "Write Program Command".
 - 3) FBA should point the unlocked area address among NADND Flash Array address map.

Figure 23. OTP lock operation flow-chart

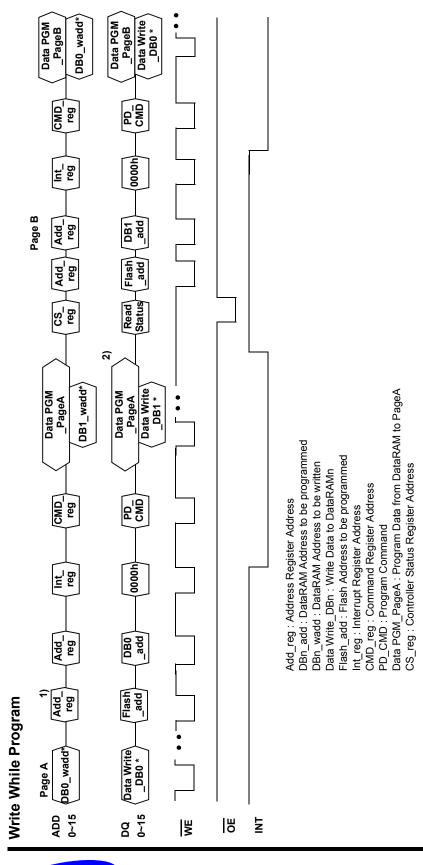




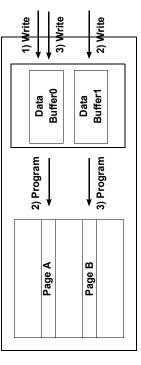
The device provides dual data buffer memory architecture. The device is capable of data-read operation from one data buffer and data-load operation to another data buffer simultaneously. This is so called the Read while Load operation with dual data buffer architecture, this feature provides the capability of executing reading data from one of data buffers during data-load operation from Flash to the other buffer simultaneously. Refer to the information for more details in "Load operation" before performing read while load operation. Simultaneous load and read operation to same data buffer is prohibited.







gram operation from anther data buffer to Flash simultaneously. Refer to the information for more details in "Program operation" before performing write while program oper-The device provides dual data buffer memory architecture. The device is capable of data-write operation and program operation simultaneously. This is so called the write while program operation with dual data buffer architecture, this feature provides the capability of executing data-write operation from host to one of data buffers during proation. Simultaneous program and write operation to same data buffer is prohibited.





ECC Operation

While the device transfers data from BufferRAM to NAND Flash Array Page Buffer for Program Operation, the device hiddenly generates ECC(24bits for main area data and 10bits for 2nd and 3rd word data of each sector spare area) and while Load operation, hiddenly generates ECC and detects error number and position and corrects 1bit error. ECC is updated by the device automatically. After Load Operation, host can know whether there is error or not by reading 'ECC Status Register'(refer to ECC Status Register Table). In addition, OneNAND supports 2bit EDC even though it is little probable that 2bit error occurs. Hence, it is not recommeded that Host reads 'ECC Status Register' for checking ECC error because the built-in Error Correction Logic of OneNAND finds out and corrects ECC error.

When the device loads NAND Flash Array main and sprea area data with ECC operation, the device does not place the newly generated ECC for main and spare area into the buffer but places ECC which was generated and written in program operation into the buffer.

Ecc operation is done during the boot loading operation.

ECC Bypass Operation

ECC bypass operation is set by 9th bit of System Configuration 1 register. In ECC Bypass operation, the device neither generates ECC result which indicates error position nor updates ECC code to NAND Flash arrary spare area in program operation(refer to ECC Result Register Tables). During Load operation, the on-chip ECC engine does not generate a new ECC internally and the values of ECC Status and Result Registers are invalid. Hence, in ECC Bypass operation, the error cannot be detected and corrected by OneNAND itself. ECC Bypass operation is not recommended to host.

Table 8. ECC Code & Result Status by ECC operation mode

| | Program operation | L | Load operation | | | | | | |
|---------------|---|--|---|-------------|--|--|--|--|--|
| Operation | ECC Code Update to NAND Flash Array Spare Area | ECC Code at BufferRAM Spare Area | ECC Status & Result Update to Registers | 1bit Error | | | | | |
| ECC operation | Update | Pre-written ECC code ⁽¹⁾ loaded | Update | Correct | | | | | |
| ECC bypass | Not update | Pre-written code loaded | Invalid | Not correct | | | | | |

NOTE

1. Pre-written ECC code: ECC code which is previously written to NAND Flash Spare Area in program operation.



Data Protection during Power Down

The device is designed to offer protection from any involuntary program/erase during power-transitions. An internal voltage detector disables all functions whenever Vcc is below about 1.3V. $\overline{\mathsf{RP}}$ pin provides hardware protection and is recommended to be kept at Vilbefore power-down.

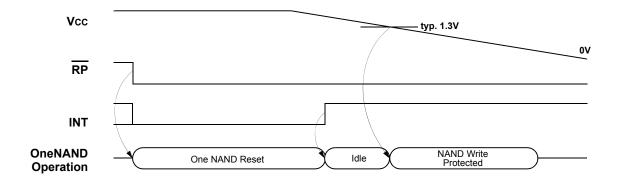


Figure 24. Data Protection during Power Down



Technical Notes

Invalid Block(s)

Invalid blocks are defined as blocks that contain one or more invalid bits whose reliability is not guaranteed by Samsung. The information regarding the invalid block(s) is so called as the invalid block information. Devices with invalid block(s) have the same quality level as devices with all valid blocks and have the same AC and DC characteristics. An invalid block(s) does not affect the performance of valid block(s) because it is isolated from the bit line and the common source line by a select transistor. The system design must be able to mask out the invalid block(s) via address mapping. The 1st block, which is placed on 00h block address, is fully guaranteed to be a valid block.

Identifying Invalid Block(s)

All device locations are erased(FFFFh) except locations where the invalid block(s) information is written prior to shipping. The invalid block(s) status is defined by the 1st word in the spare area. Samsung makes sure that either the 1st or 2nd page of every invalid block has non-FFFFh data at the 1st word of sector0. Since the invalid block information is also erasable in most cases, it is impossible to recover the information once it has been erased. Therefore, the system must be able to recognize the invalid block(s) based on the original invalid block information and create the invalid block table via the following suggested flow chart(Figure 24). Any intentional erasure of the original invalid block information is prohibited.

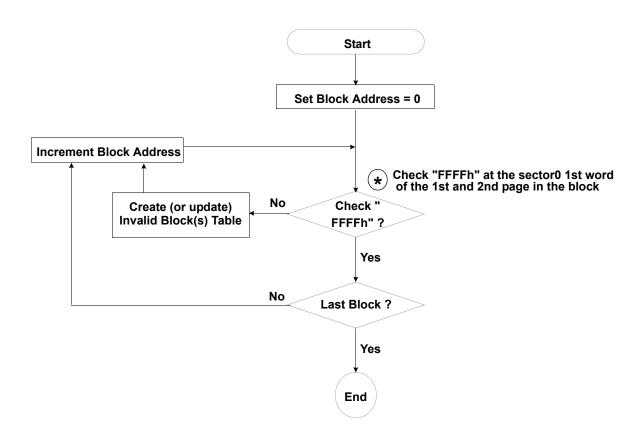


Figure 25. Flow chart to create invalid block table.

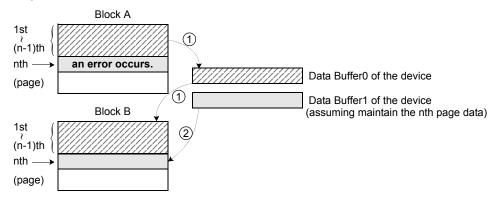


Error in write or load operation

Within its life time, additional invalid blocks may develop with the device. Refer to the qualification report for the actual data. The following possible failure modes should be considered to implement a highly reliable system. In the case of status read failure after erase or program, block replacement should be done. Because program status fail during a page program does not affect the data of the other pages in the same block, block replacement can be executed with a page-sized buffer by finding an erased empty block and reprogramming the current target data and copying the rest of the replaced block.

| | Failure Mode | Detection and Countermeasure sequence |
|-----------------------|--------------------|--|
| Mrito | Erase Failure | Status Read after Erase> Block Replacement |
| Write Program Failure | | Status Read after Program> Block Replacement |
| Load | Single Bit Failure | Error Correction by ECC mode of the device |

Block Replacement



When an error happens in the nth page of the Block 'A' during program operation.

Then, copy the data in the 1st ~ (n-1)th page to the same location of the Block 'B' via data buffer0.

Copy the nth page data of the Block 'A' in the data buffer1 to the nth page of another free block. (Block 'B')

Do not further erase or program Block 'A' by creating an 'invalid Block' table or other appropriate scheme.



^{*} Step1

^{*} Step2

Boot Sequence

One of the best features OneNAND has is that it can be a booting device itself since it contains an internally built-in boot loader despite the fact that its core architecture is based on NAND Flash. Thus, OneNAND does not make any additional booting device necessary for a system, which imposes extra cost or area overhead on the overall system.

As the system power is turned on, the boot code originally stored in NAND Flash Arrary is moved to BootRAM automatically and then fetched by CPU through the same interface as SRAM's or NOR Flash's if the size of the boot code is less than 1KB. If its size is larger than 1KB and less than or equal to 2KB, only 1KB of it can be moved to BootRAM automatically and fetched by CPU, and the rest of it can be loaded into one of the DataRAMs whose size is 1KB by Load Command and CPU can take it from the DataRAM after finishing the code-fetching job for BootRAM. If its size is larger than 2KB, the 1KB portion of it can be moved to BootRAM automatically and fetched by CPU, and its remaining part can be moved to DRAM through two DataRAMs using dual buffering and taken by CPU to reduce CPU fetch time.

A typical boot scheme usually used to boot the system with OneNAND is explained at Figure 26 and Figure 27. In this boot scheme, boot code is comprised of BL1, where BL stands for Boot Loader, BL2, and BL3. Moreover, the size of the boot code is larger than 2KB (the 3rd case above). BL1 is called primary boot loader in other words. Here is the table of detailed explanations about the function of each boot loader in this specific boot scheme.

Boot Loaders in OneNAND

| Boot Loader | Description |
|----------------|--|
| BL1 | Moves BL2 from NAND Flash Array to DRAM through two DataRAMs using dual buffering |
| BL2 | Moves OS image (or BL3 optionally) from NAND Flash Array to DRAM through two DataRams using dual buffering |
| BL3 (Optional) | Moves or writes the image through USB interface |

NAND Flash Array of OneNAND is divided into the partitions as described at Figure 26 to show where each component of code is located and how much portion of the overall NAND Flash Array each one occupies. In addition, the boot sequence is listed below and depicted at Figure 27.

Boot Sequence:

- Power is on
 BL1 is loaded into BootRAM
- BL1 is executed in BootRAM
 BL2 is loaded into DRAM through two DataRams using dual buffering by BL1
- BL2 is executed in DRAM
 OS image is loaded into DRAM through two DataRams using dual buffering by BL2
- 4. OS is running



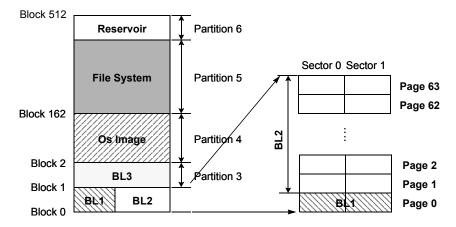
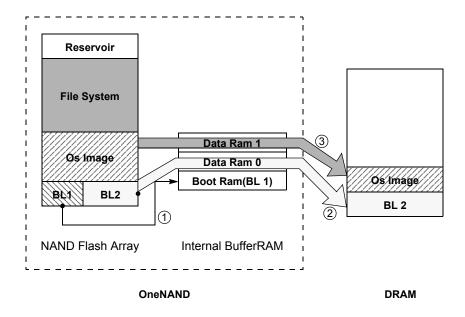


Figure 26. Partition of NAND Flash array



2 and 3 can be copied into DRAM through two DataRAMs using dual buffering

Figure 27. OneNAND Boot Sequence



Methods of Determining Interrupt Status

There are two methods of determining Interrupt Status on the OneNAND. Using the INT pin or monitoring the Interrupt Status Register Bit.

The OneNAND INT pin is an output pin function used to notify the Host when a command has been completed. This provides a hardware method of signaling the completion of a program, erase, or load operation.

In its normal state, the INT pin is high if the INT polarity bit is default. Before a command is written to the command register, the INT bit must be written to '0' so the INT pin transitions to a low state indicating start of the operation. Upon completion of the command operation by the OneNAND's internal controller, INT returns to a high state.

INT is an open drain output allowing multiple INT outputs to be Or-tied together. INT does not float to a hi-Z condition when the chip is deselected or when outputs are disabled. Refer to section 2.8 for additional information about INT.

INT can be implemented by tying INT to a host GPIO or by continuous polling of the Interrupt status register.

The INT Pin to a Host General Purpose I/O

INT can be tied to a Host GPIO to detect the rising edge of INT, signaling the end of a command operation.

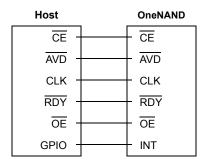


This can be configured to operate either synchronously or asynchronously as shown in the diagrams below.



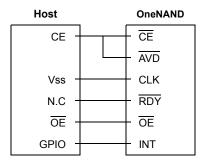
Synchronous Mode Using the INT Pin

When operating synchronously, INT is tied directly to a Host GPIO.



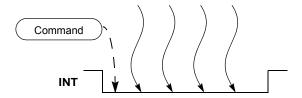
Asynchronous Mode Using the INT Pin

When configured to operate in an asynchronous mode, /CE and /AVD of the OneNAND are tied to /CE of the Host. CLK is tied to the Host Vss (Ground). /RDY is tied to a no-connect. /OE of the OneNAND and Host are tied together and INT is tied to a GPIO.



Polling the Interrupt Register Status Bit

An alternate method of determining the end of an operation is to continuously monitor the Interrupt Status Register Bit instead of using the INT pin.

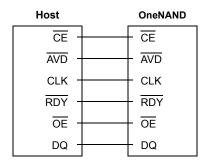


This can be configured in either a synchronous mode or an asynchronous mode.



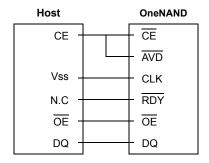
Synchronous Mode Using Interrupt Status Register Bit Polling

When operating synchronously, /CE, /AVD, CLK, /RDY, /OE, and DQ pins on the host and OneNAND are tied together.



Asynchronous Mode Using Interrupt Status Register Bit Polling

When configured to operate in an asynchronous mode, /CE and /AVD of the OneNAND are tied to /CE of the Host. CLK is tied to the Host Vss (Ground). /RDY is tied to a no-connect. /OE and DQ of the OneNAND and Host are tied together.

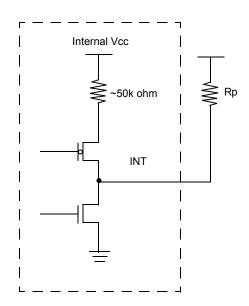


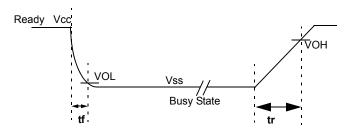


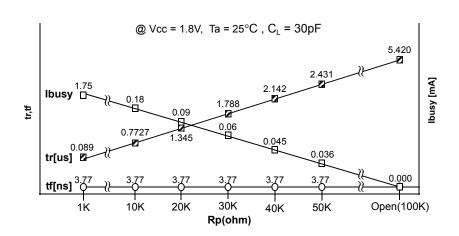
Determing Rp Value

Because the pull-up resistor value is related to tr(INT), an appropriate value can be obtained by the following reference charts.

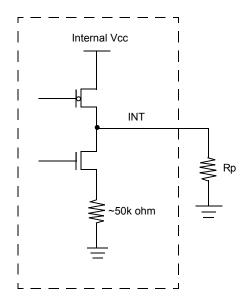
INT pol = 'High'

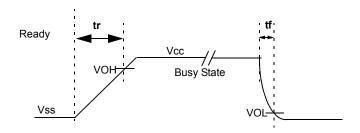


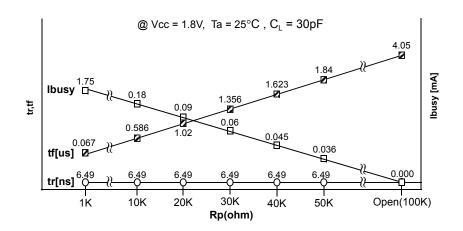




INT pol = 'Low'







ABSOLUTE MAXIMUM RATINGS

| Davamatav | Parameter | | | Rating | | Unit |
|------------------------------|------------|--------|----------------|---------------|---------------|------|
| raiailletei | | Symbol | KFG2816Q1M | KFG2816D1M | KFG2816U1M | Unit |
| Voltage on any pin relative | Vcc | Vcc | -0.5 to + 2.45 | -0.6 to + 4.6 | -0.6 to + 4.6 | V |
| to Vss | All Pins | Vin | -0.5 to + 2.45 | -0.6 to + 4.6 | -0.6 to + 4.6 | v |
| Tomporatura Undar Dias | Extended | Thias | -30 to +125 | -30 to +125 | -30 to +125 | · °C |
| Temperature Under Bias | Industrial | I bias | - | - | -40 to +125 | , .C |
| Storage Temperature | | Tstg | -65 to +150 | -65 to +150 | -65 to +150 | °C |
| Short Circuit Output Current | | los | 5 | 5 | 5 | mA |
| Operating Temperature | Extended | TA | -30 to + 85 | -30 to + 85 | -30 to + 85 | · °C |
| Operating Temperature | Industrial | TA | - | - | -40 to + 85 | |

NOTES:

9.2 RECOMMENDED OPERATING CONDITIONS (Voltage reference to GND)

| Parameter | Symbol | 1 | .8V Devic | e | 2. | 65V Devi | се | 3 | 3.3V Devic | е | Unit |
|----------------|----------|-----|-----------|------|-----|----------|-----|-----|------------|-----|-------|
| raiametei | Symbol | Min | Тур. | Max | Min | Тур. | Max | Min | Тур. | Max | Oiiit |
| | Vcc-core | 1.7 | 1.8 | 1.95 | 2.4 | 2.65 | 2.9 | 2.7 | 3.3 | 3.6 | V |
| Supply Voltage | Vcc-IO | 1.7 | 1.0 | 1.95 | 2.4 | 2.05 | 2.9 | 2.1 | 3.3 | 3.0 | |
| | Vss | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | V |

NOTES:

- 1. The system power should reach 1.7V after POR triggering level(typ. 1.5V) within 400us.
- 2. Vcc-Core should reach the operating voltage level prior to Vcc-IO or at the same time.



^{1.} Minimum DC voltage is -0.5V on Input/ Output pins. During transitions, this level should not fall to POR level(typ. 1.5V).

Maximum DC voltage is Vcc+0.6V on input / output pins which, during transitions, may overshoot to Vcc+2.0V for periods <20ns.

Permanent device damage may occur if ABSOLUTE MAXIMUM RATINGS are exceeded. Functional operation should be restricted to the conditions detailed in the operational sections of this data sheet. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

DC CHARACTERISTICS

| Danamatan | Course la sal | Took Condition | _ | 1.8 | V dev | ice | 2.6 | 5V dev | vice | 3.3 | V dev | ice | 11 |
|--|---------------|--|---------|---------------------------|-------|--------------|--------------|--------|--------------|--------------|-------|---------------|------|
| Parameter | Symbol | Test Conditions | N | | Тур | Max | Min | Тур | Max | Min | Тур | Max | Unit |
| Input Leakage Current | ILI | VIN=Vss to Vcc, Vcc=V | CCmax | - 1.0 | 1 | + 1.0 | - 1.0 | 1 | + 1.0 | - 1.0 | - | + 1.0 | μА |
| Output Leakage Cur- rent | llo | VOUT=Vss to Vcc, Vcc= CE or OE=ViH(Note 1) | VCCmax, | - 1.0 | - | + 1.0 | - 1.0 | - | + 1.0 | - 1.0 | - | + 1.0 | μА |
| Active Asynchronous Read Current (Note 2) | Icc1 | CE=VIL, OE=VIH | | 1 | 8 | 15 | - | 10 | 20 | - | 10 | 20 | mA |
| Active Burst Read Cur- | Icc2 | CE=VIL, OE=VIH | 54MHz | 1 | 12 | 20 | - | 20 | 30 | - | 20 | 30 | mA |
| rent (Note 2) | 1002 | CE-VIL, OE-VIH | 1MHz | - | 3 | 4 | - | 4 | 6 | - | 4 | 6 | mA |
| Active Write Current (Note 2) | Іссз | CE=VIL, OE=VIH | • | 1 | 8 | 15 | - | 10 | 20 | - | 10 | 20 | mA |
| Active Load Current (Note 3) | ICC4 | CE=VIL, OE=VIH, WE=\ | /ін, | 1 | 20 | 25 | - | 20 | 30 | - | 20 | 30 | mA |
| Active Program Cur- rent (Note 3) | ICC5 | CE=VIL, OE=VIH, WE=\ | /ін, | 1 | 20 | 25 | - | 20 | 30 | - | 20 | 30 | mA |
| Erase/Multi Block Erase Current (Note 3) | Icc6 | CE=VIL, OE=VIH, WE=\ VIN=VIH or VIL, 64blocks | , | 1 | 15 | 20 | - | 18 | 25 | - | 18 | 25 | mA |
| Standby Current | Isb | CE= RP=Vcc ± 0.2V | | 1 | 10 | 50 | - | 15 | 50 | - | 15 | 50 | μА |
| Input Low Voltage | VIL | - | | -0.5 | - | 0.4 | -0.5 | - | 0.4 | 0 | - | 8.0 | V |
| Input High Voltage | VIH | - | | Vccq- 0.4 | - | VCCq +0.4 | Vccq- 0.4 | - | VCCq +0.4 | 0.7*V CCq | - | Vccq | ٧ |
| Output Low Voltage | Vol | IOL = 100 μA , VCC=VCC VCCq=VCCqmin | Cmin , | 1 | - | 0.2 | - | - | 0.2 | - | - | 0.22* Vccq | ٧ |
| Output High Voltage | Vон | IOH = -100 μA , VCC=VC VCCq=VCCqmin | Cmin , | Vcc _q - 0.1 | - | - | Vccq- 0.4 | - | - | 0.8*V CCq | - | - | ٧ |

^{1.} $\overline{\text{CE}}$ should be VIH for RDY. IOBE should be '0' for INT.

^{2.} Icc active for Host access

^{3.} ICC active while Internal operation is in progress.

VALID BLOCK

| Parameter | Symbol | Min | Тур. | Max | Unit |
|--------------------|--------|-----|------|-----|--------|
| Valid Block Number | N∨B | 251 | - | 256 | Blocks |

NOTES:

- 1. The device may include invalid blocks when first shipped. Additional invalid blocks may develop while being used. The number of valid blocks is presented with both cases of invalid blocks considered. Invalid blocks are defined as blocks that contain one or more bad bits. Do not erase or program factory-marked bad blocks.
- 2. The 1st block, which is placed on 00h block address, is fully guaranteed to be a valid block.

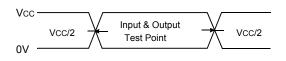
CAPACITANCE(TA = 25 °C, Vcc = 1.8V/2.65V/3.3V, f = 1.0MHz)

| Item | Symbol | Test Condition | Min | Max | Unit |
|-------------------------|--------|---------------------|-----|-----|------|
| Input Capacitance | CIN1 | VIN=0V | - | 10 | pF |
| Control Pin Capacitance | CIN2 | V _{IN} =0V | - | 10 | pF |
| Output Capacitance | Соит | Vout=0V | - | 10 | pF |

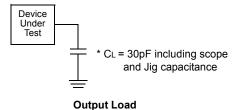
NOTE: Capacitance is periodically sampled and not 100% tested.

AC TEST CONDITION(Vcc = 1.8V/2.65V/3.3V)

| Pa | ameter | Value | |
|--------------------------------|--------------|-----------|--|
| Input Pulse Levels | | 0V to Vcc | |
| Input Disc and Fall Times | CLK | 3ns | |
| Input Rise and Fall Times | other inputs | 5ns | |
| Input and Output Timing Levels | | Vcc/2 | |
| Output Load | | CL = 30pF | |



Input Pulse and Test Point



Synchronous Burst Read

| Parameter | Symbol | KFG2816X1M | | 11-14 |
|---|--------------------|------------|------|-------|
| | | Min | Max | Unit |
| Clock | CLK | 1 | 54 | MHz |
| Clock Cycle | tclk | 18.5 | - | ns |
| Initial Access Time(at 54MHz) | tiaa | - | 76 | ns |
| Burst Access Time Valid Clock to Output Delay | tва | - | 14.5 | ns |
| AVD Setup Time to CLK | tavds | 7 | - | ns |
| AVD Hold Time from CLK | tavdh | 7 | - | ns |
| Address Setup Time to CLK | tacs | 7 | - | ns |
| Address Hold Time from CLK | tach | 7 | - | ns |
| Data Hold Time from Next Clock Cycle | tврн | 4 | - | ns |
| Output Enable to Data | toe | - | 20 | ns |
| CE Disable to Output High Z | tcez ¹⁾ | - | 20 | ns |
| OE Disable to Output High Z | toez ¹⁾ | - | 17 | ns |
| CE Setup Time to CLK | tces | 7 | - | ns |
| CLK High or Low Time | tclkh/L | tclk/3 | - | ns |
| CLK ²⁾ to RDY valid | trdyo | - | 14.5 | ns |
| CLK to RDY Setup Time | trdya | - | 14.5 | ns |
| RDY Setup Time to CLK | trdys | 4 | - | ns |
| CE low to RDY valid | tcer | - | 15 | ns |



Note

1. If \overline{OE} is disabled at the same time or before \overline{CE} is disabled, the output will go to high-z by toez(max. 17ns). If \overline{CE} is disabled at the same time or before \overline{OE} is disabled, the output will go to high-z by toez(max. 20ns). If \overline{CE} and \overline{OE} are disabled at the same time, the output will go to high-z by toez(max. 17ns). These parameters are not 100% tested.

2. It is the following clock of address fetch clock.

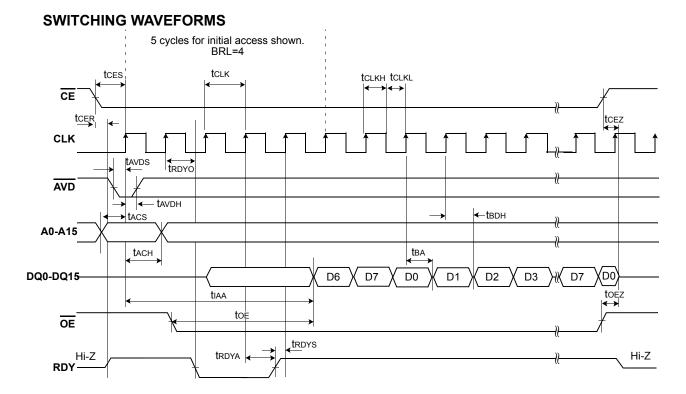


Figure 28. 8 Word Linear Burst Mode with Wrap Around

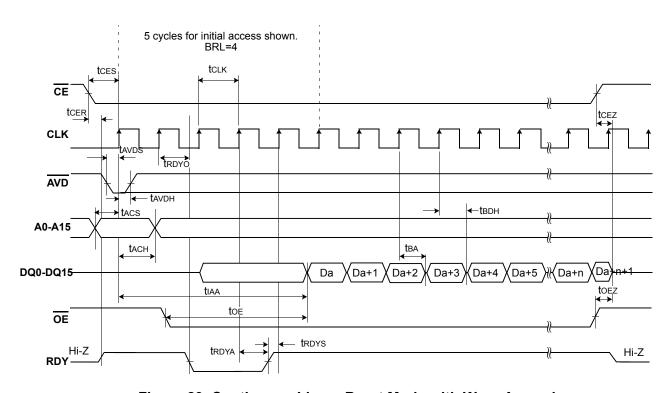


Figure 29. Continuous Linear Burst Mode with Wrap Around

NOTE: In order to avoid a bus conflict the \overline{OE} signal is enabled on the next rising edge after \overline{AVD} is going high.



Asynchronous Read

| Parameter | Symbol | KFG2 | Unit | | |
|---|--------|------|------|-------|--|
| Farameter | Symbol | Min | Max | Oilit | |
| Access Time from CE Low | tce | - | 76 | ns | |
| Asynchronous Access Time from AVD Low | taa | - | 76 | ns | |
| Asynchronous Access Time from address valid | tacc | - | 76 | ns | |
| Read Cycle Time | trc | 76 | - | ns | |
| AVD Low Time | tavdp | 12 | - | ns | |
| Address Setup to rising edge of AVD | taavds | 7 | - | ns | |
| Address Hold from rising edge of AVD | taavdh | 7 | - | ns | |
| Output Enable to Output Valid | toE | - | 20 | ns | |
| CE Setup to AVD falling edge | tca | 0 | - | ns | |
| CE Disable to Output & RDY High Z ¹⁾ | tcez | - | 20 | ns | |
| OE Disable to Output & RDY High Z ¹⁾ | toez | - | 17 | ns | |

SWITCHING WAVEFORMS

Case 1 : Valid Address and AVD Transition occur before CE is driven to Low

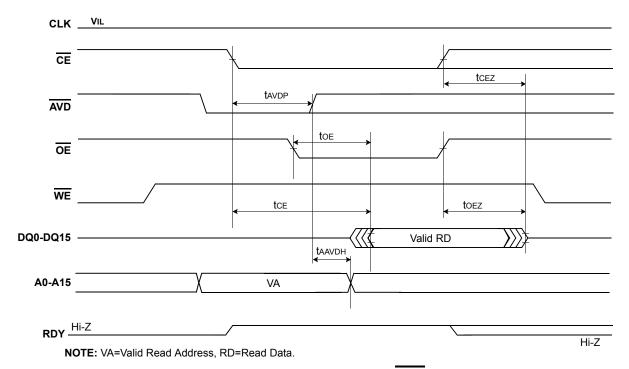


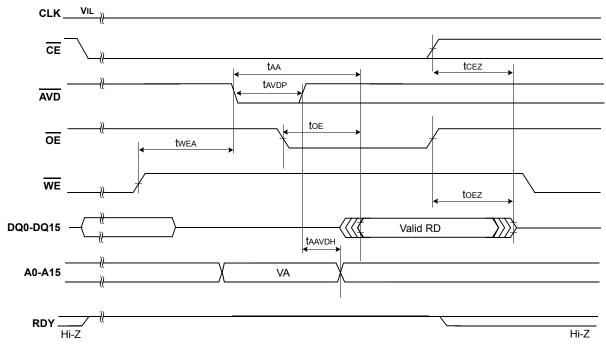
Figure 30. Asynchronous Read Mode(AVD toggling)

^{1.} If \overline{OE} is disabled at the same time or before \overline{CE} is disabled, the output will go to high-z by toez(max. 17ns). If \overline{CE} is disabled at the same time or before \overline{OE} is disabled, the output will go to high-z by toez(max. 20ns).

If CE and OE are disabled at the same time, the output will go to high-z by toez(max. 17ns).

These parameters are not 100% tested.

Case 2 : AVD Transition occurs after CE is driven to Low and Valid Address Transition occurs before AVD is driven to Low

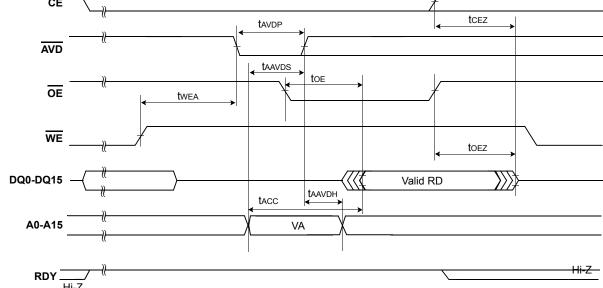


NOTE: VA=Valid Read Address, RD=Read Data.

Figure 31. Asynchronous Read Mode(AVD toggling)

Case 3: AVD Transition occur after CE is driven to Low and Valid Address Transition occurs after AVD is driven to Low

CLK VIL



NOTE: VA=Valid Read Address, RD=Read Data.

Figure 32. Asynchronous Read Mode(AVD toggling)



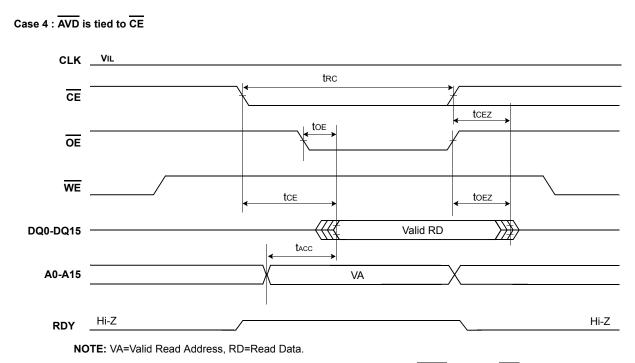


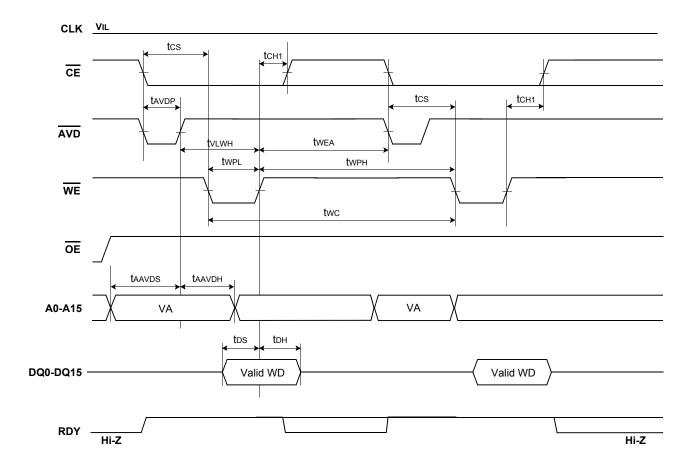
Figure 33. Asynchronous Read Mode(AVD tied to CE)

AC CHARACTERISTICS Asynchronous write operation

| Parameter | | 0 | | | | |
|-------------------------------------|----------------|--------|-----|-----|-----|------|
| | | Symbol | Min | Тур | Max | Unit |
| WE Cycle Time | | twc | 70 | - | - | ns |
| AVD low pulse width | | tavdp | 12 | - | - | ns |
| Address Setup to rising edge of AVD | | taavds | 7 | - | - | ns |
| Address Setup to falling edge of WE | | tawes | 0 | | | |
| Address Hold to rising edge of AVD | | taavdh | 7 | - | - | ns |
| Address Hold to rising edge of WE | | tан | 10 | | | ns |
| Data Setup to rising edge of WE | | tos | 10 | - | - | ns |
| Data Hold from rising edge of WE | | tон | 4 | - | - | ns |
| CE Setup to falling edge of WE | | tcs | 0 | - | - | ns |
| CE Hold from rising edge of WE | AVD toggled | tcH1 | 0 | - | - | ns |
| CE Hold from rising edge of WE | AVD tied to CE | tcH2 | 10 | - | - | ns |
| WE Pulse Width | | twpl | 40 | - | - | ns |
| WE Pulse Width High | | twpн | 30 | - | - | ns |
| AVD Disable to WE Disable | | t∨∟wн | 15 | - | - | ns |
| WE Disable to AVD Enable | | twea | 15 | - | - | ns |



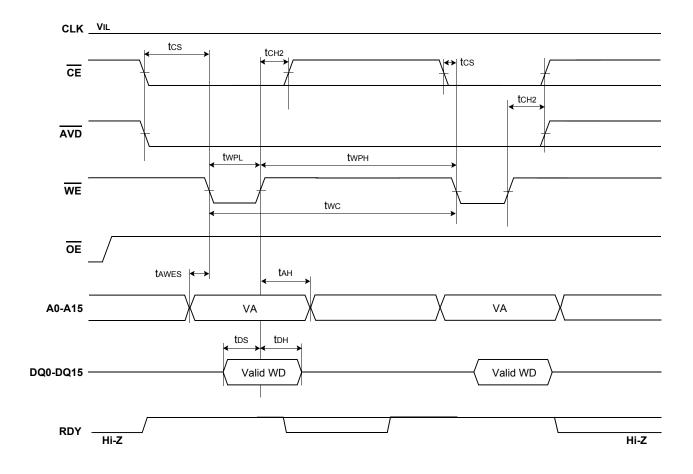
Case 1 : AVD is toggled every write cycle



NOTE: VA=Valid Read Address, WD=Write Data.

Figure 34. Latched Asynchronous Write Mode(AVD toggling)

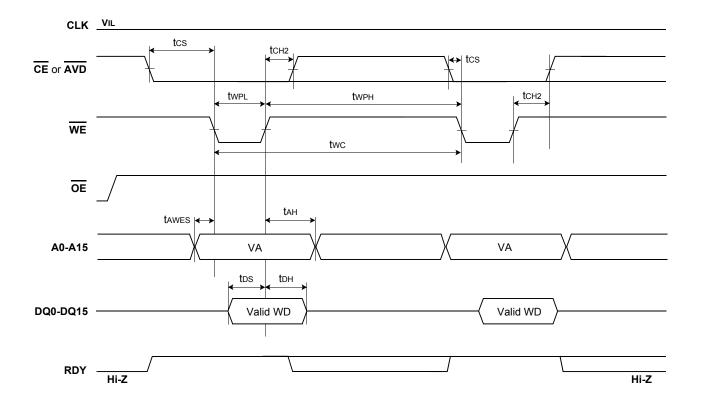
Case 2 : $\overline{\text{AVD}}$ is synchronized with $\overline{\text{CE}}$



NOTE: VA=Valid Read Address, WD=Write Data.

Figure 35. Asynchronous Write Mode(AVD toggling)

Case 3 : AVD is tied to CE



NOTE: VA=Valid Read Address, WD=Write Data.

Figure 36. Asynchronous Write Mode(AVD tied to CE)



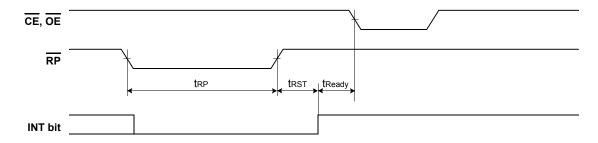
Reset

| Parameter | Symbol | KFG2816X1M | | Unit |
|--|--------|------------|-----|-------|
| r al allieter | | Min | Max | Offic |
| RP & Reset Command Latch(During Load Routines) to INT High (Note) | trst | - | 10 | μS |
| RP & Reset Command Latch(During Program Routines) to INT High (Note) | trst | - | 20 | μS |
| RP & Reset Command Latch(During Erase Routines) to INT High (Note) | trst | - | 500 | μS |
| RP & Reset Command Latch(NOT During Internal Routines) to Read Mode (Note) | trst | - | 10 | μS |
| INT High to Read Mode (Note) | tReady | 200 | - | ns |
| RP Pulse Width | trp | 200 | - | ns |

NOTE: These parameters are tested based on INT bit of interrupt register. Because the time on INT pin is related to the pull-up and pull-down resistor value. Please refer to page 66 and 67.

SWITCHING WAVEFORMS

Warm Reset



Hot Reset

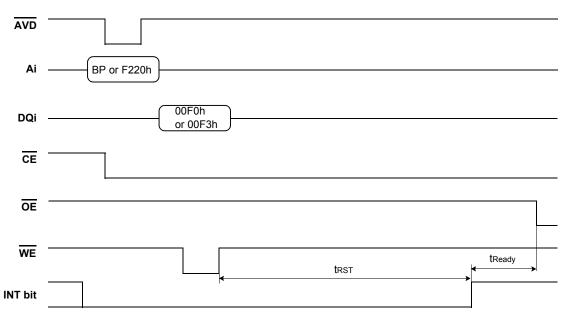


Figure 37. Reset Timing



Performance

| Parameter | | Symbol | Min | Тур | Max | Unit |
|--|-------------|--------------|-----|-----|------|--------|
| Sector Load time(Note 1) | | t RD1 | - | 35 | 45 | μS |
| Page Load time(Note 1) | | tRD2 | - | 50 | 75 | μS |
| Sector Program time(Note 1) | | tPGM1 | - | 320 | 720 | μS |
| Page Program time(Note 1) | | tPGM2 | - | 350 | 750 | μS |
| OTP Access Time(Note 1) | | tотр | - | 600 | 1000 | ns |
| Lock/Unlock/Lock-tight Time(Note 1) | | tLOCK | - | 600 | 1000 | ns |
| Erase Suspend Time(Note 1) | | tesp | - | 400 | 500 | μS |
| Erase Resume Time(Note 1) | 1 Block | ters1 | - | 2 | 3 | ms |
| | 2~64 Blocks | ters2 | | 4 | 5 | ms |
| Number of Partial Program Cycles in the sector (Including main and spare area) | | NOP | - | - | 2 | cycles |
| Block Erase time (Note 1) | 1 Block | tBERS1 | - | 2 | 3 | ms |
| | 2~64 Blocks | tBERS2 | - | 4 | 5 | ms |
| Multi BlocK Erase Verify Read time(Note 1) | | t RD3 | 1 | 115 | 135 | μS |

NOTES:



^{1.} These parameters are tested based on INT bit of interrupt register. Because the time on INT pin is related to the pull-up and pull-down resistor value. Please refer to page 66 and 67.

SWITCHING WAVEFORMS

Load Operations

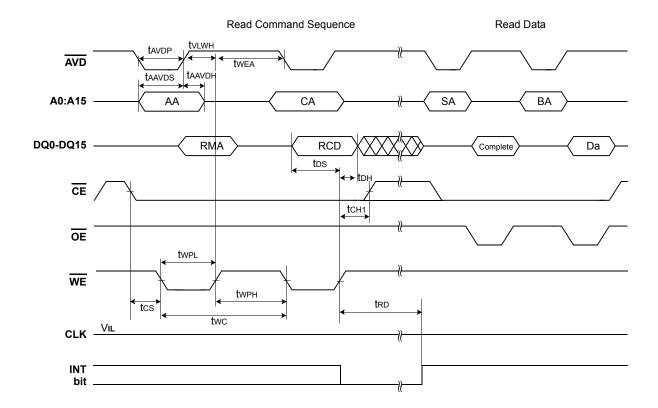


Figure 38. Load Operation Timing

NOTES:

1. AA = Address of address register

CA = Address of command register

LCD = Load Command

LMA = Address of memory to be loaded

BA = Address of BufferRAM to load the data

BD = Program Data

SA = Address of status register

- 2. "In progress" and "complete" refer to status register
- 3. Status reads in this figure is asynchronous read, but status read in synchronous mode is also supported.



SWITCHING WAVEFORMS

Program Operations

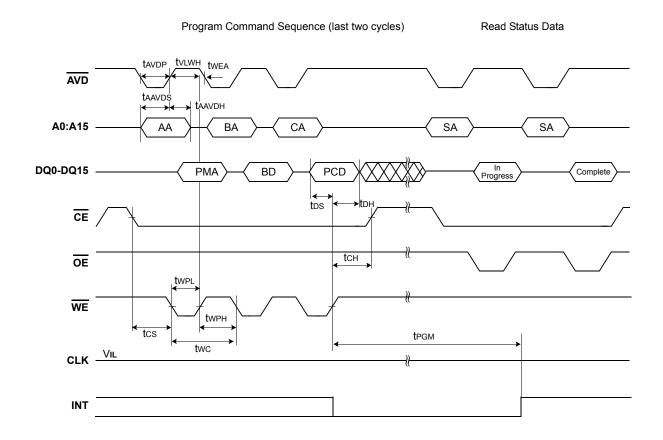


Figure 39. Program Operation Timing

NOTES:

- 1. AA = Address of address register
 - CA = Address of command register
 - PCD = Program Command
 - PMA = Address of memory to be programmed
 - BA = Address of BufferRAM to load the data
 - BD = Program Data
 - SA = Address of status register
- 2. "In progress" and "complete" refer to status register
- 3. Status reads in this figure is asynchronous read, but status read in synchronous mode is also supported.



SWITCHING WAVEFORMS

Erase Operation

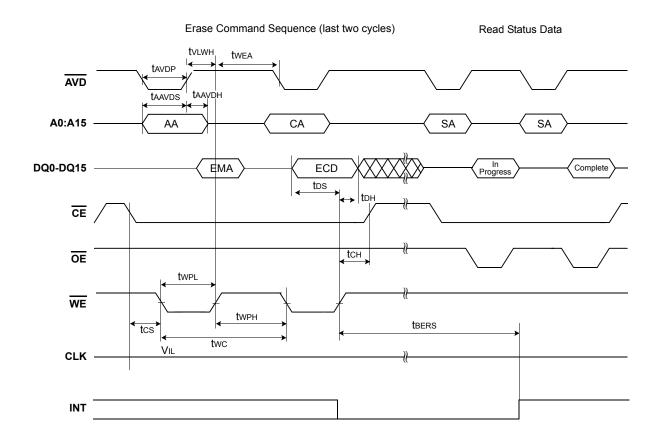


Figure 40. Block Erase Operations

NOTES:

1. AA = Address of address register

CA = Address of command register

ECD = Erase Command

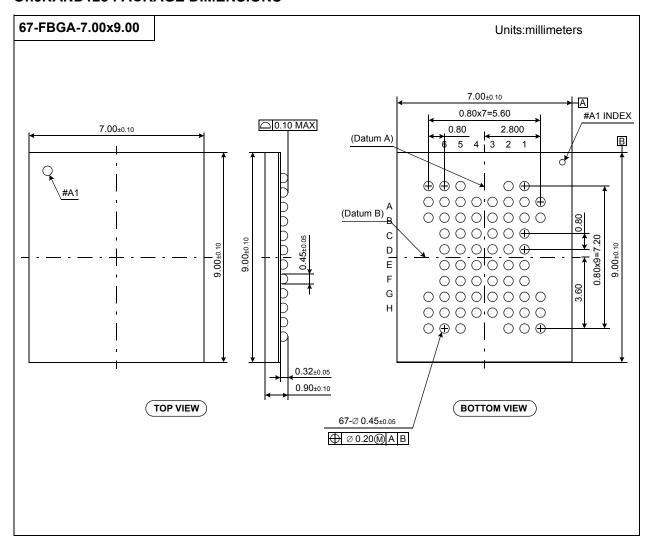
EMA = Address of memory to be erased

SA = Address of status register

- 2. "In progress" and "complete" refer to status register
- 3. Status reads in this figure is asynchronous read, but status read in synchronous mode is also supported.



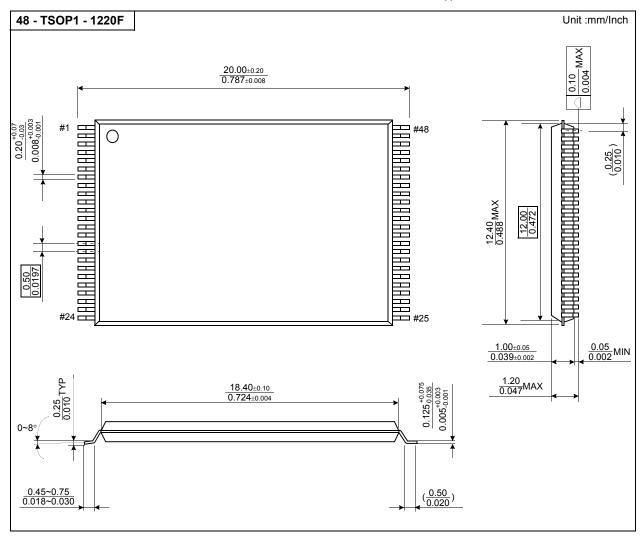
OneNAND128 PACKAGE DIMENSIONS





PACKAGE DIMENSIONS

48-PIN LEAD/LEAD FREE PLASTIC THIN SMALL OUT-LINE PACKAGE TYPE(I)





ORDERING INFORMATION

